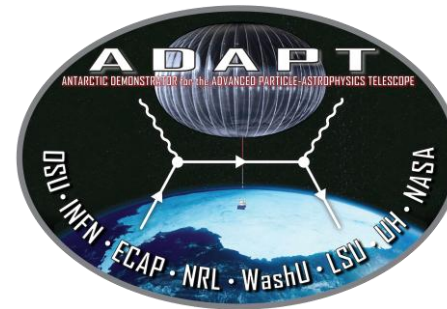


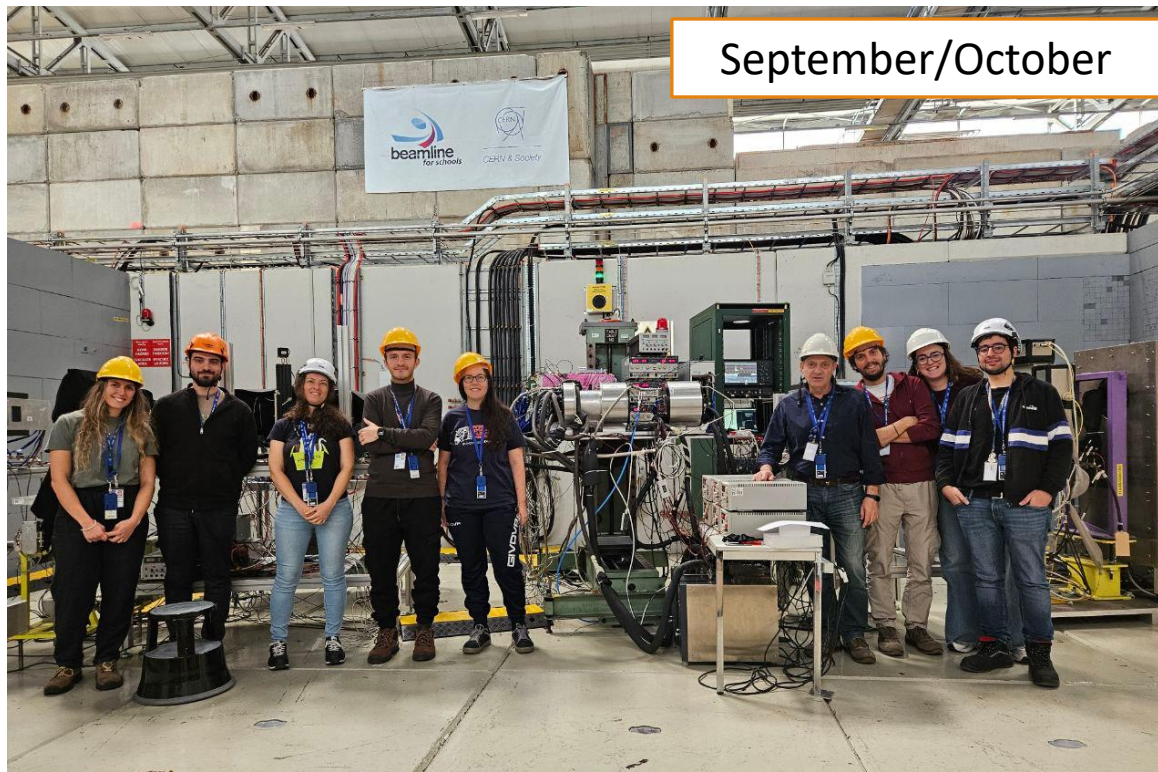


ACD @ CERN PS results

PIERPAOLO LOIZZO, University of Trento/INFN

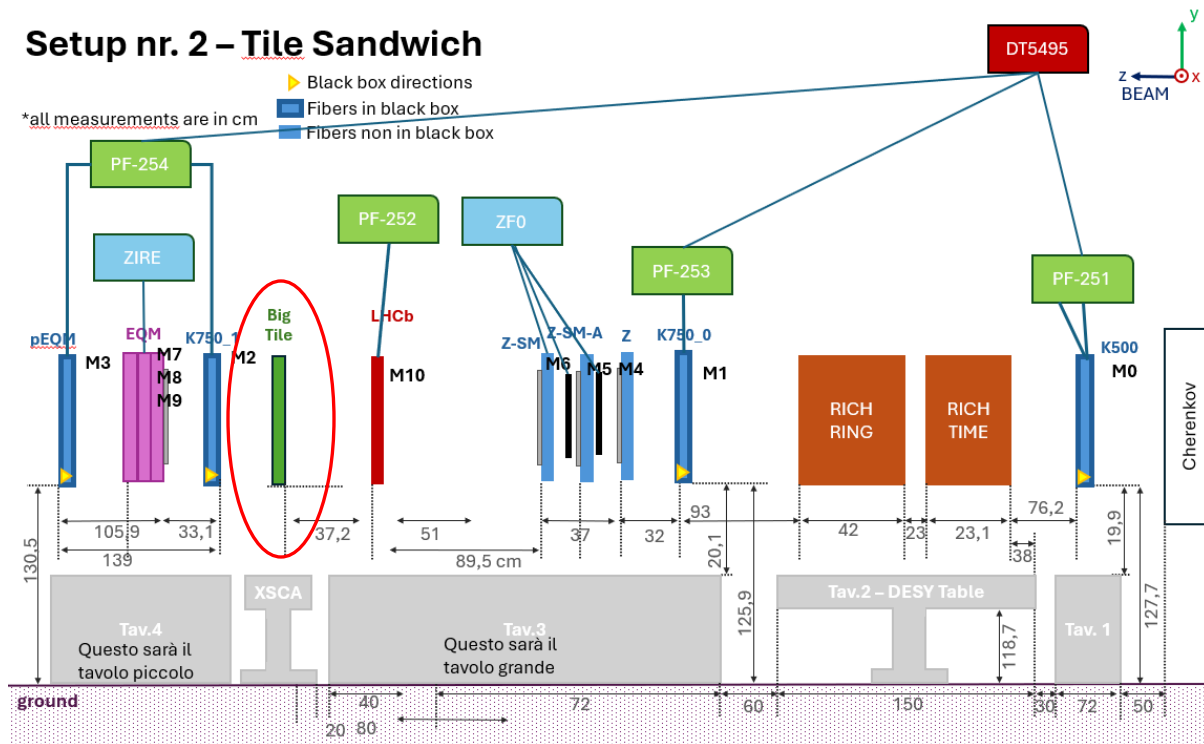
ADAPT COLLABORATION MEETING – BARI, ITALY – 4, 7 NOVEMBER 2025

The team (not all of it)



On the beamline

Setup nr. 2 – Tile Sandwich

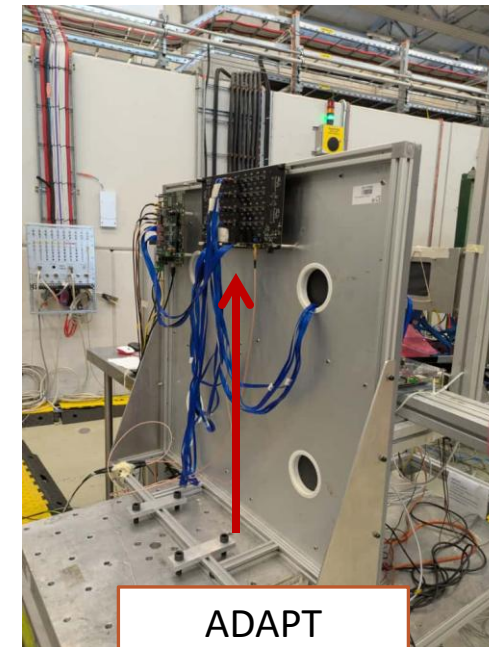


By. R. Pillera

Front view with
LHCb module



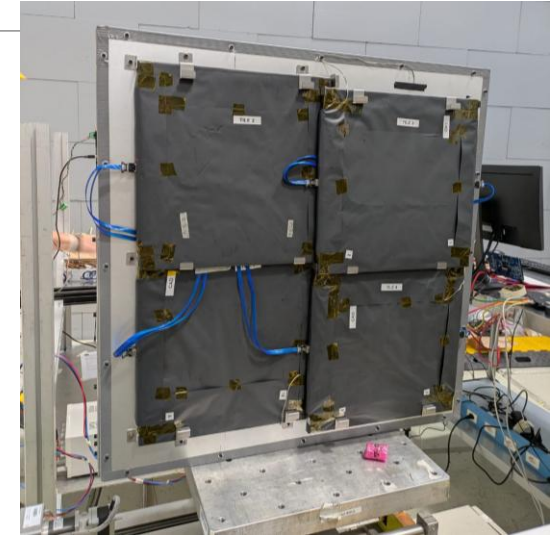
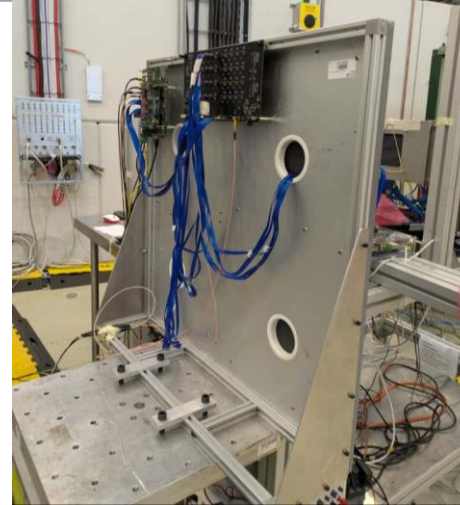
Back view



ADAPT
concentrator

Tile and readout layout

- Four tiles mounted on a panel with stand-offs
- BETA board and concentrator placed on the back of the panel
- Support mounted on XSCA table

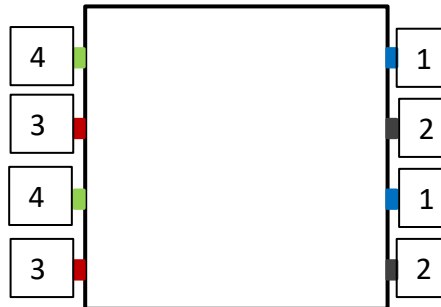
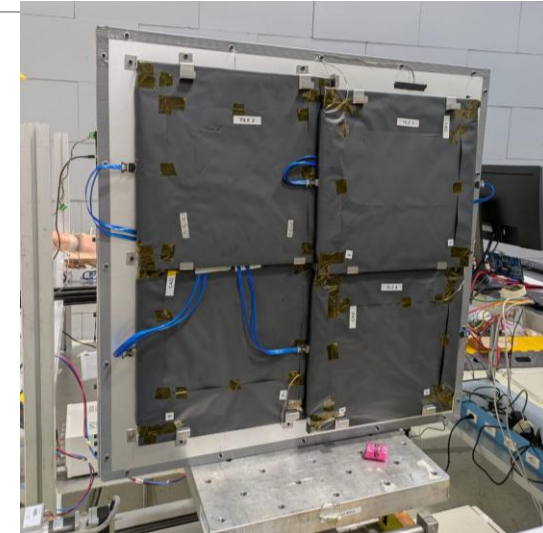
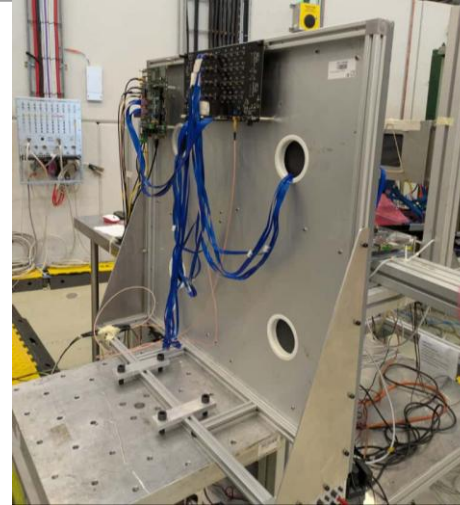


- Acquisition in external trigger
- Trigger distributed by DT5495 board
- Trigger as an AND of several Scintillating Fiber Tracker modules along the beam line



Tile and readout layout (PS September)

- Each scintillator tile is readout by 16 SiPMs located on two SiPM edge carriers
- Each channels is an analog OR between two SiPMs ($6 \times 6 \text{ mm}^2$ - $3 \times 3 \text{ mm}^2$), done at the concentrator level
- 1 quadrant = 32 channels

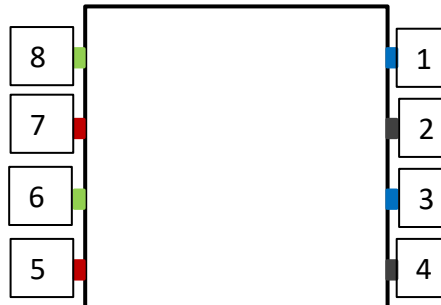
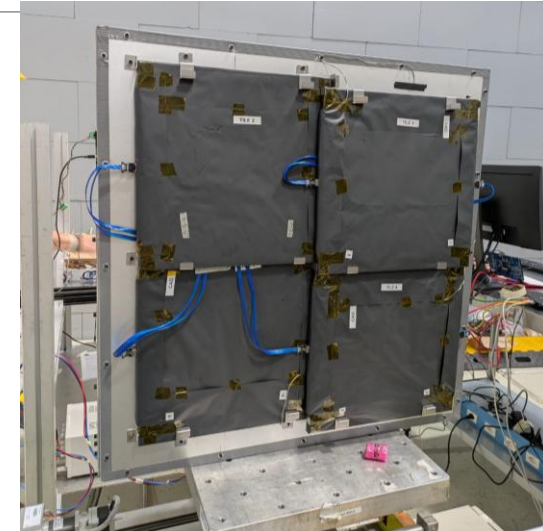
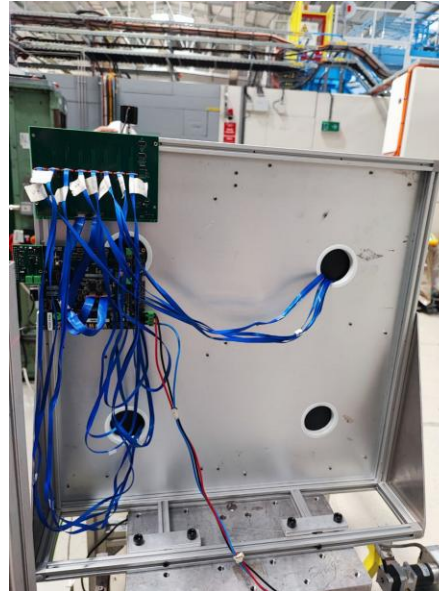


«ADAPT» definitive version of cables, concentrator, SiPM edge carriers

PCB 5	T2	PCB 6	PCB 2	T3	PCB 1
PCB 9	T5	PCB 10	PCB 8	T4	PCB 7

Tile and readout layout (PS July)

- Each scintillator tile is readout by 16 SiPMs located on two SiPM edge carriers
- Each channels is correspond to a single SiPM
- 1 quadrant = 64 channels

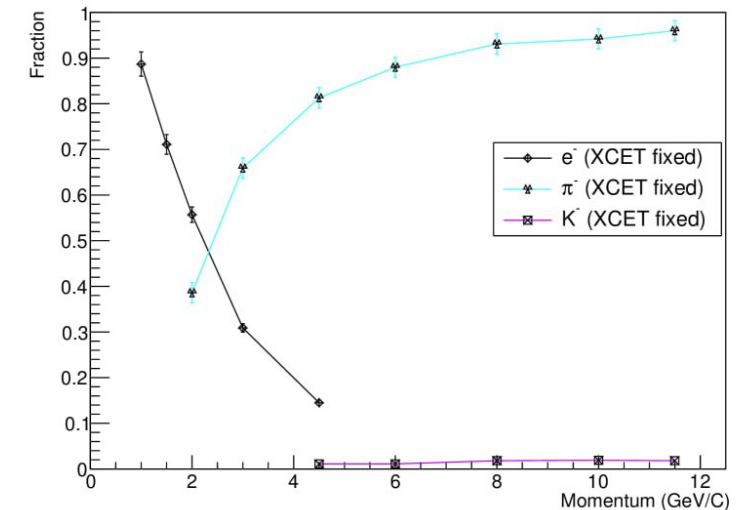
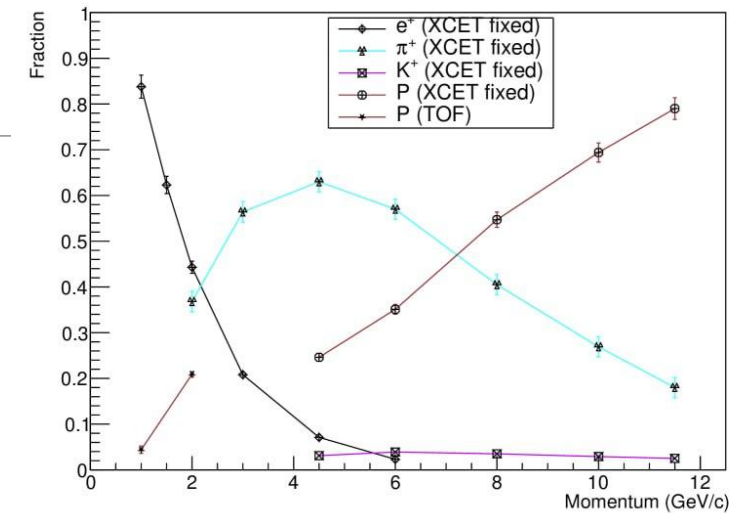


«ADAPT» definitive
version of cables,
concentrator, SiPM
edge carriers

PCB 5	T2	PCB 6	PCB 2	T3	PCB 1
PCB 9	T5	PCB 10	PCB 8	T4	PCB 7

Beams and acquisitions

- ❑ Several beams selected within positive and negative beams
- ❑ Beam size, intensity, composition vary with the selected momentum
- ❑ Check tile response with the Or-ed concentrator
- ❑ Study tile/quadrant efficiency with digitized charge
- ❑ Study tile/quadrant efficiency with trigger (validation)
- ❑ Repeat studies on critical positions (interfaces between tiles)



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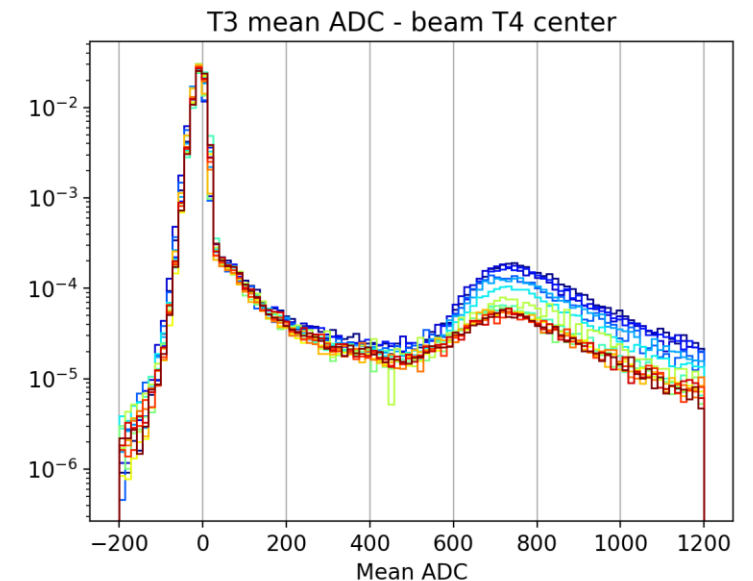
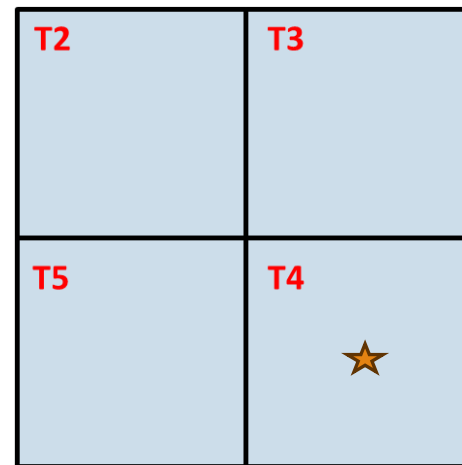
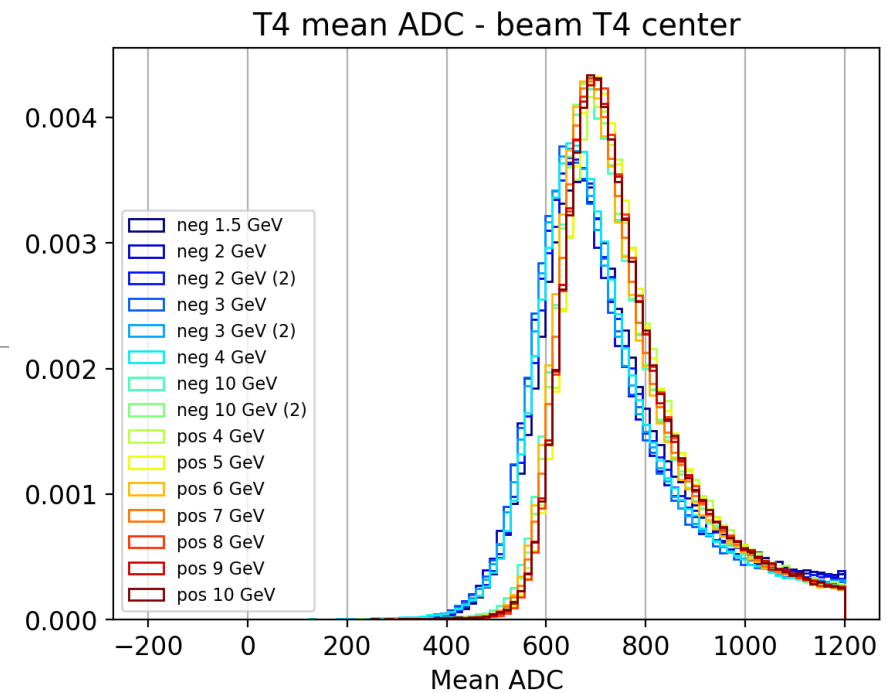
This is a preliminary analysis !!!

A more detailed and in-depth study is required, combining data from all subdetectors throughout the beam test.

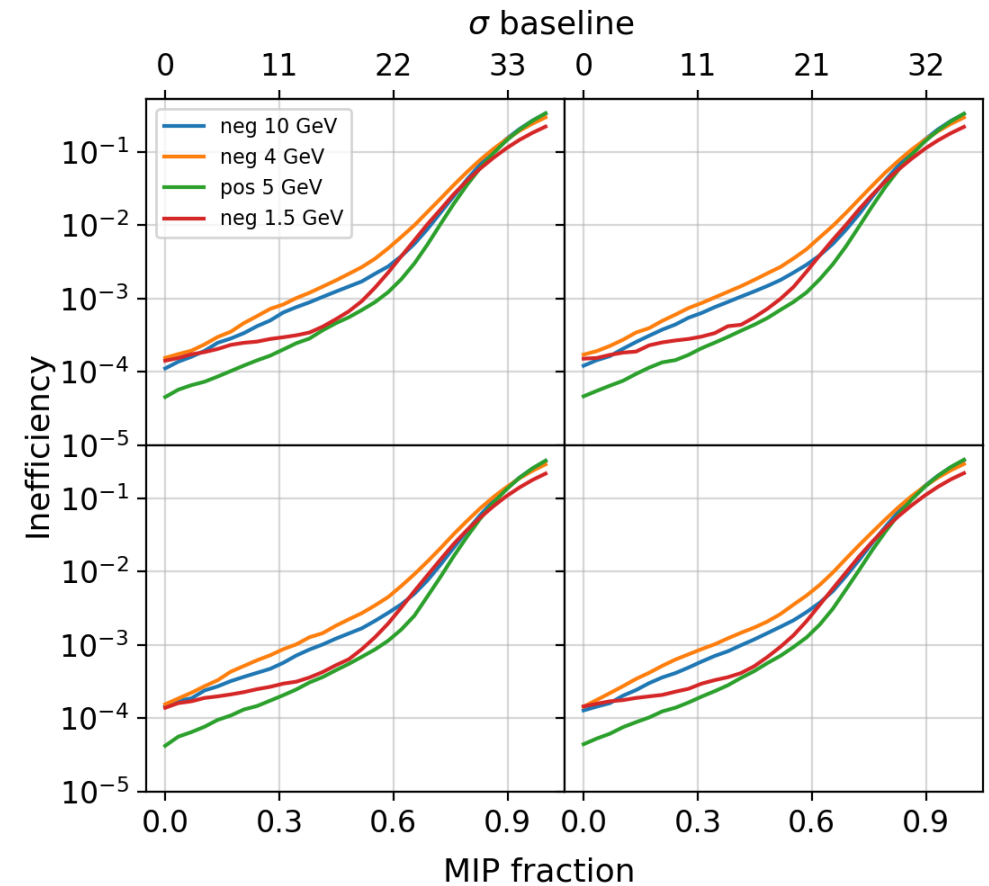
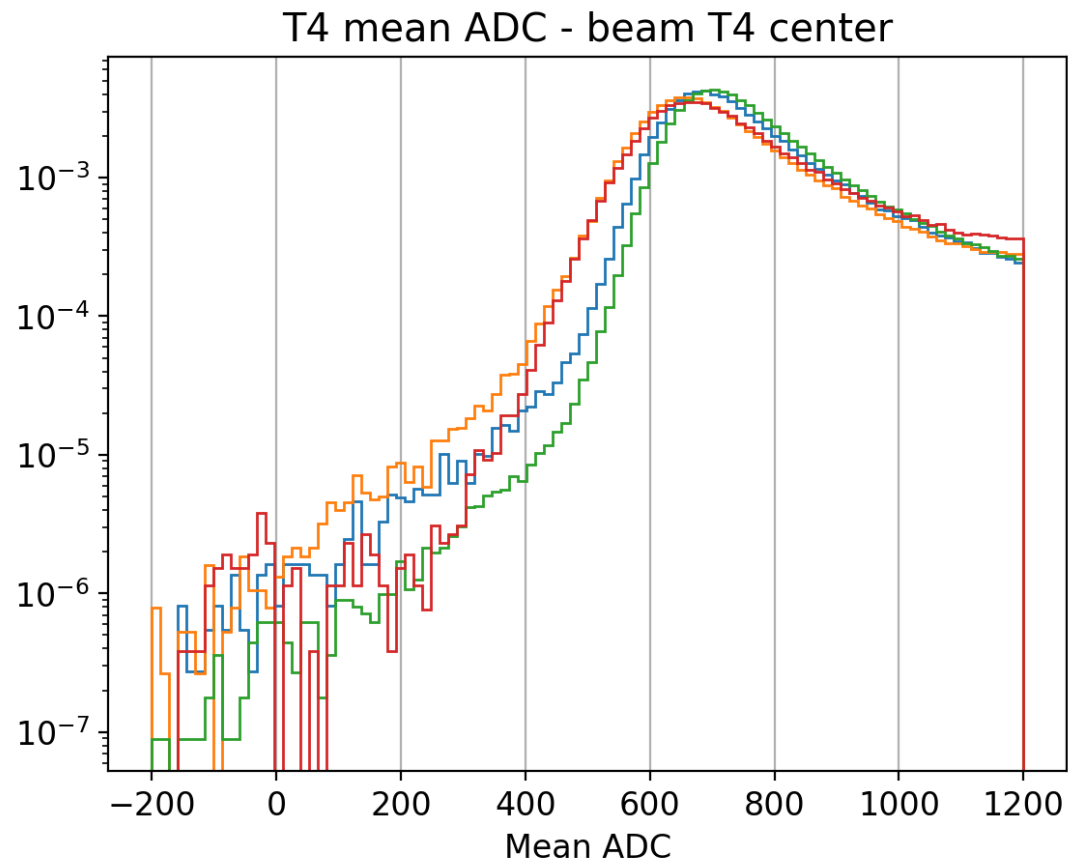
BETA Digitized Charge

Tile centers – T4

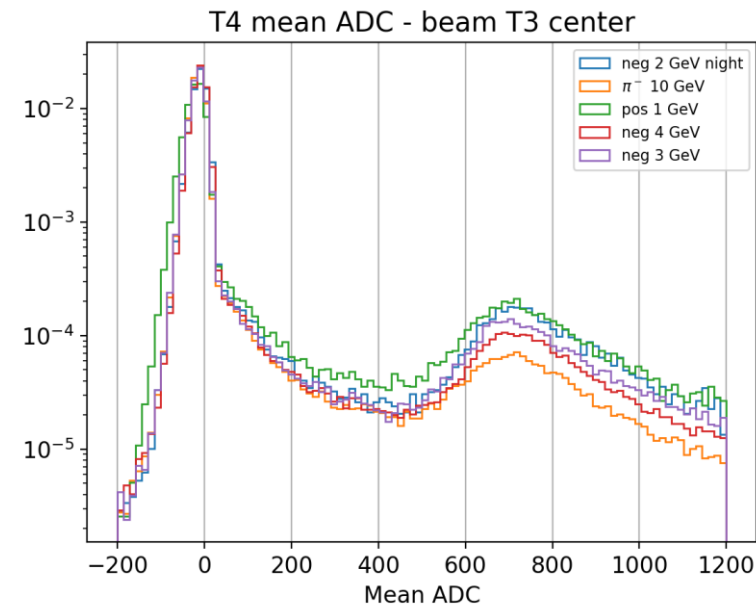
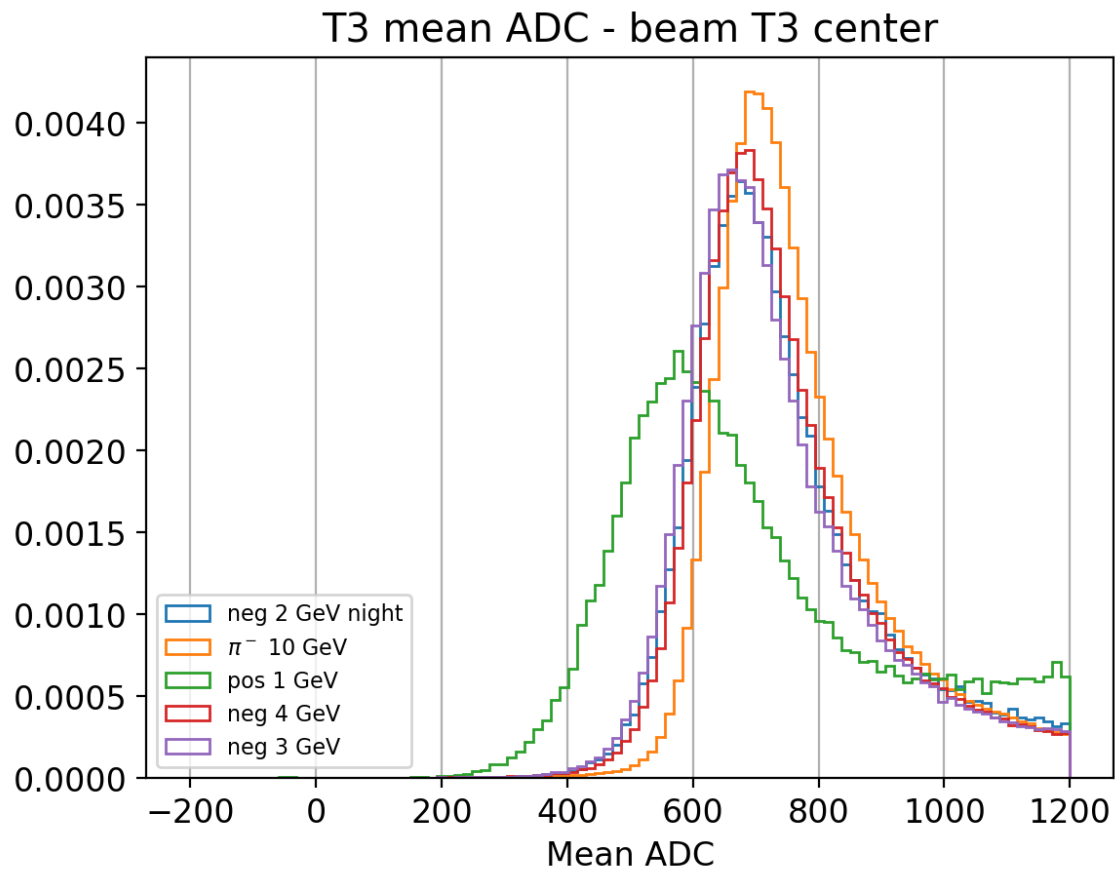
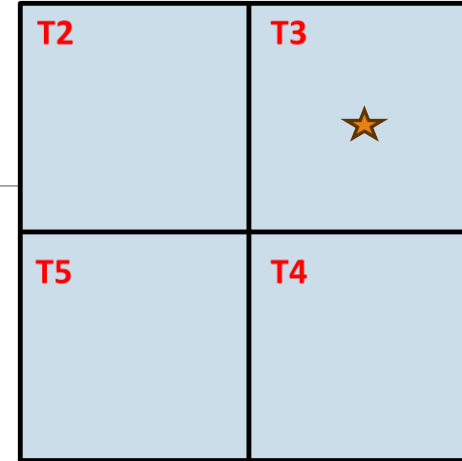
- Tile T4 experienced several beam types. Two families appears
- Not an issue of BETA configurations or for a specific slot of runs.
- Beams in the lower charge distribution family:
 - 2 GeV, -3 GeV, -1.5 GeV, -4 GeV, -3 GeV
- Looking at other tiles off-beam, the MPV for asynchronous (?) charge is unchanged



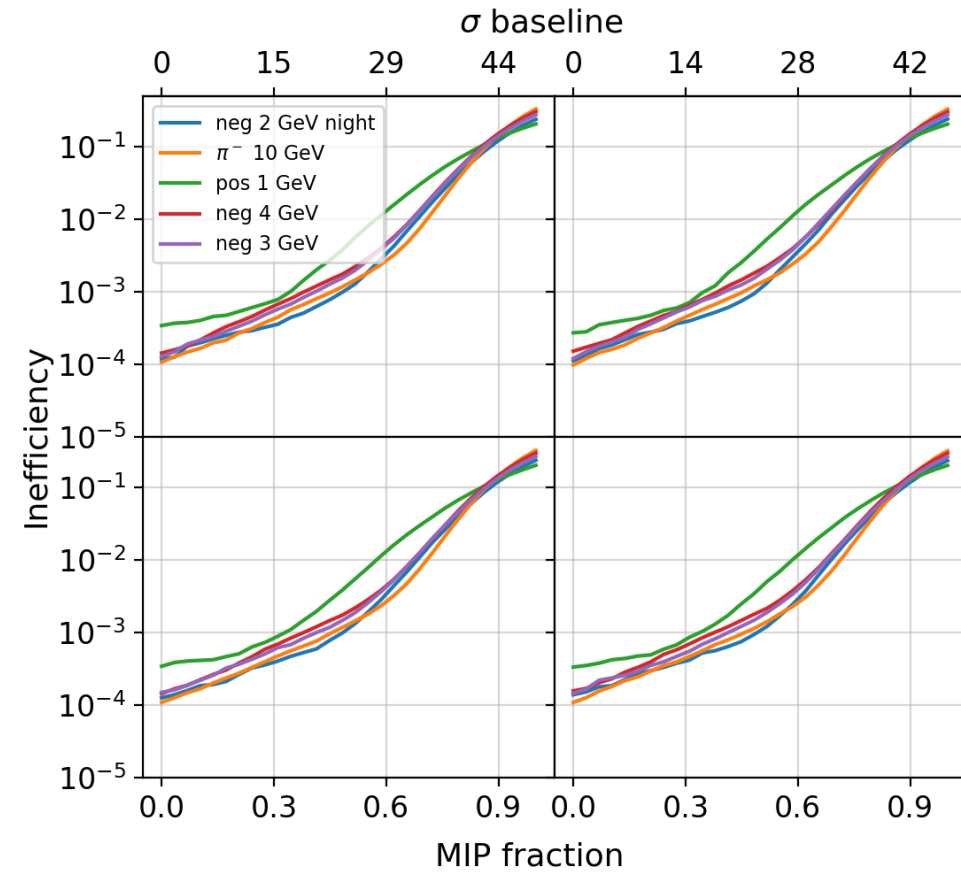
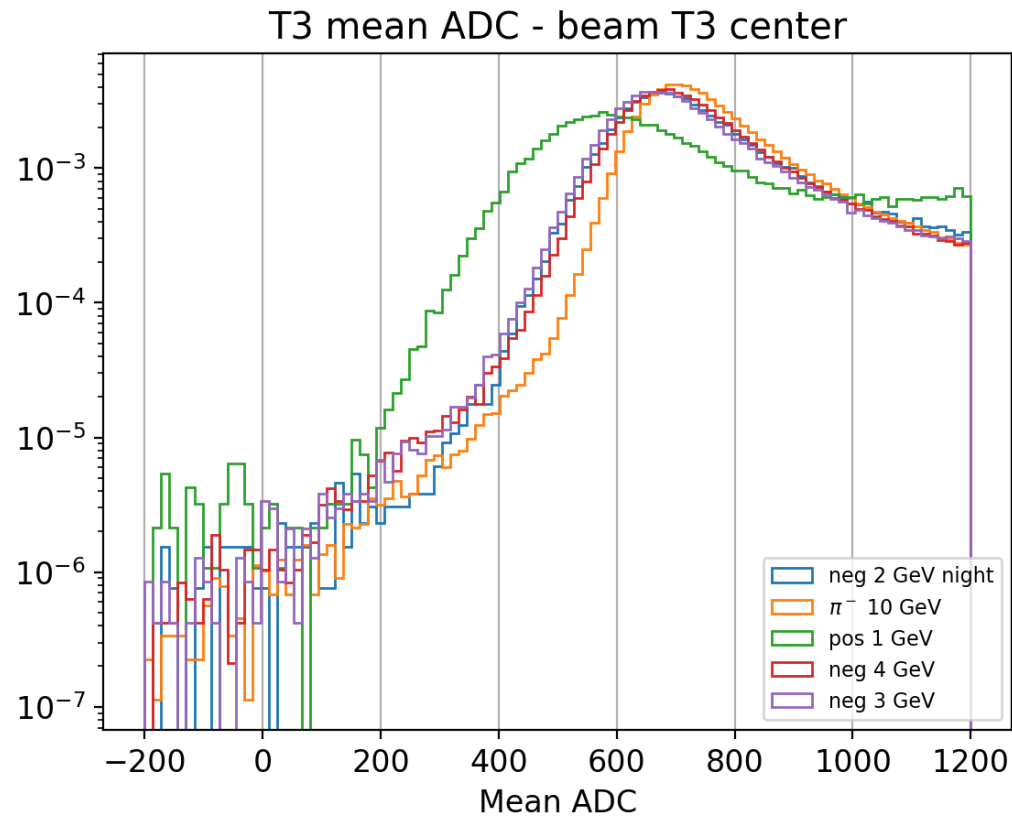
Tile centers – T4



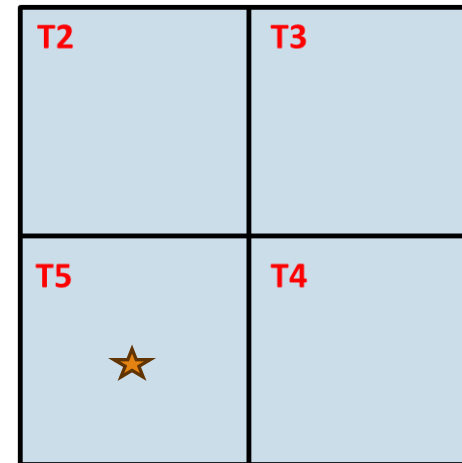
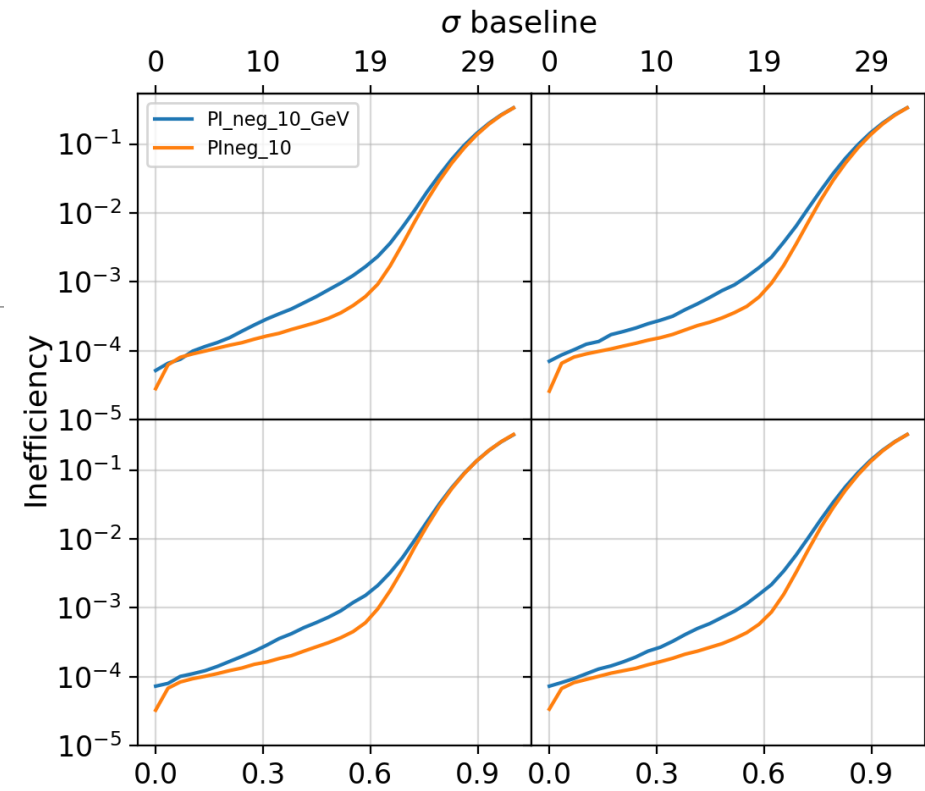
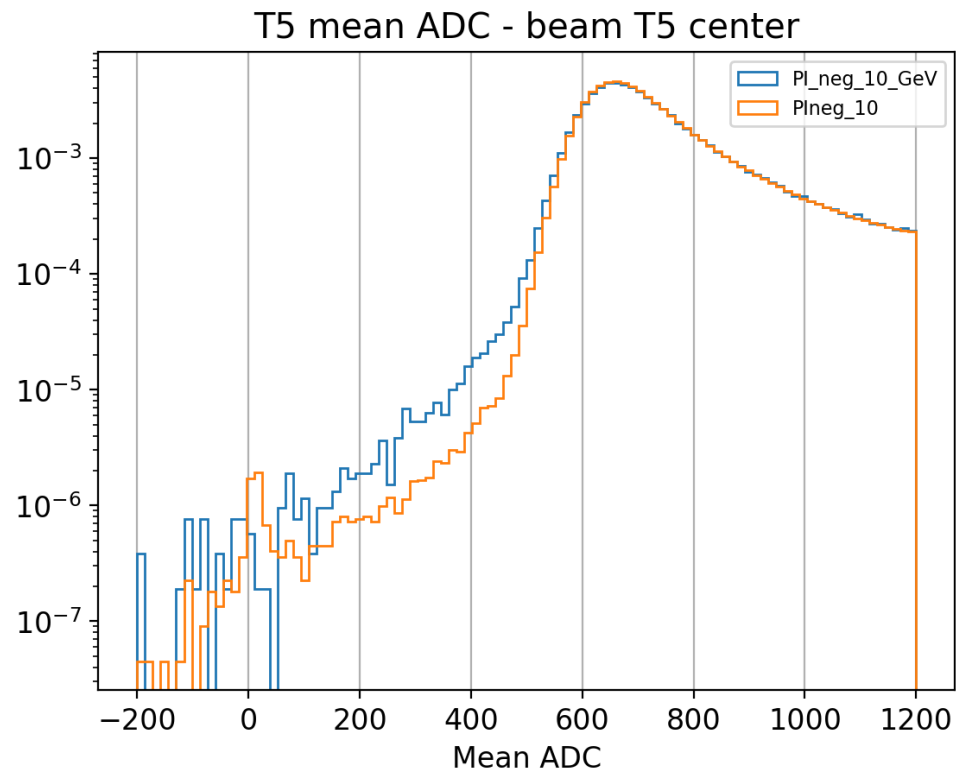
Tile centers – T3



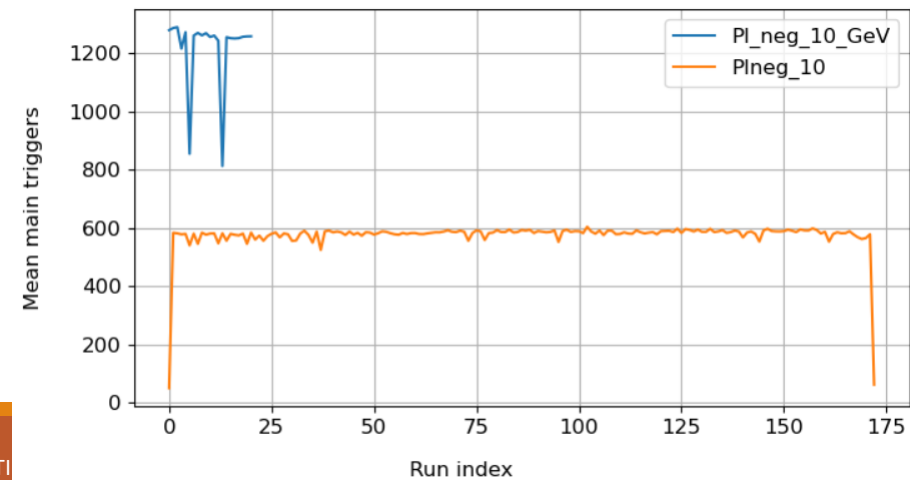
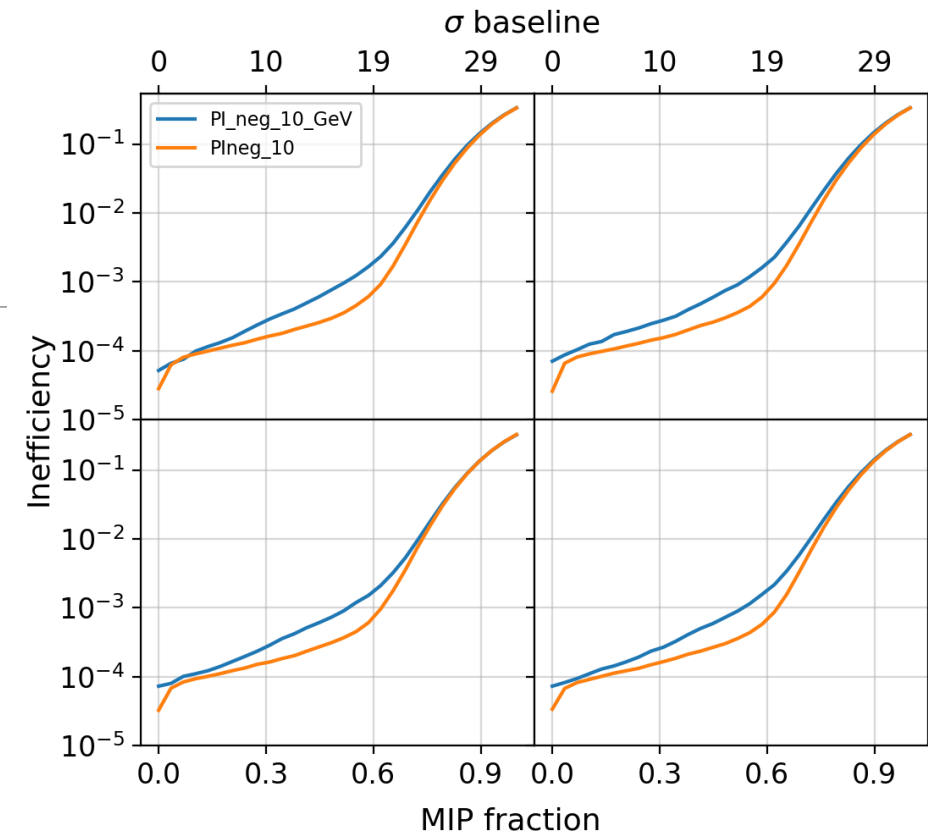
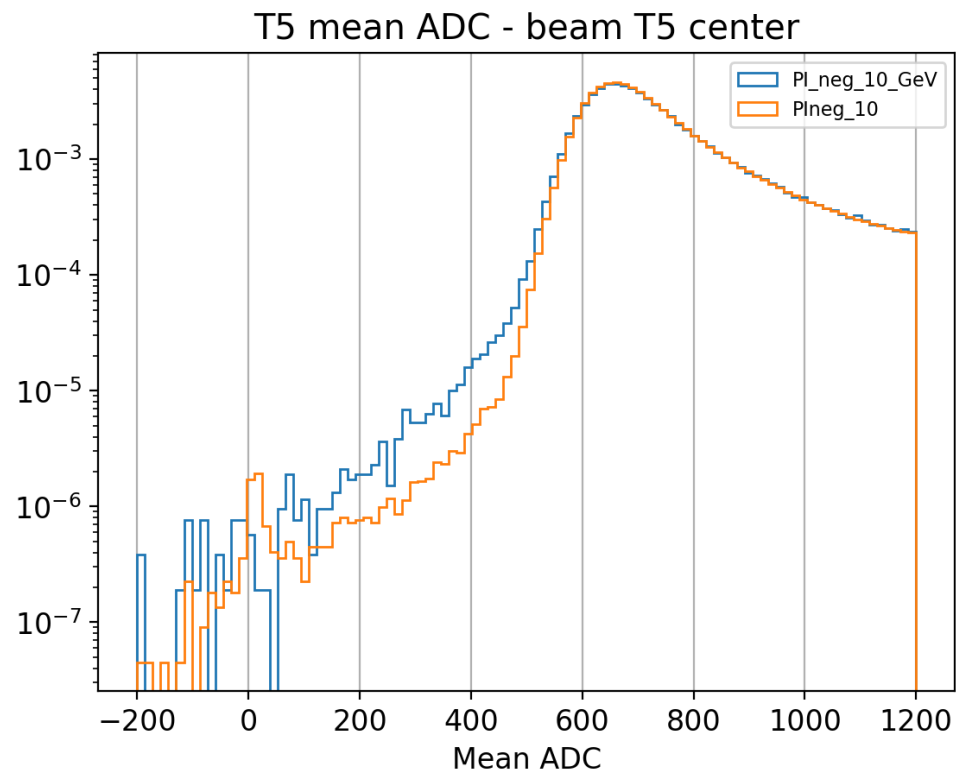
Tile centers –T3



Tile centers – T5

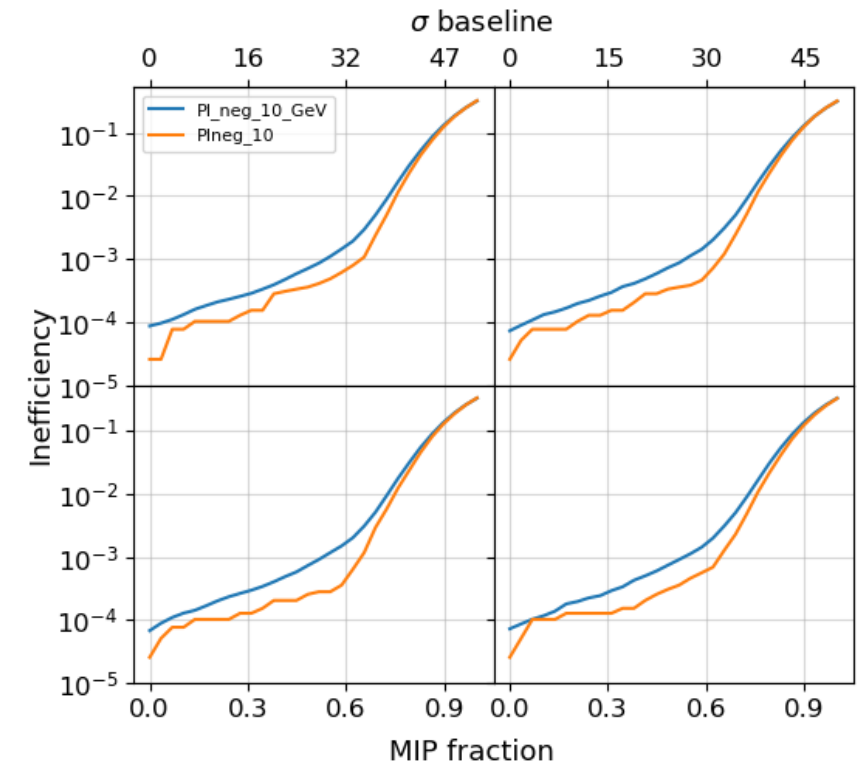
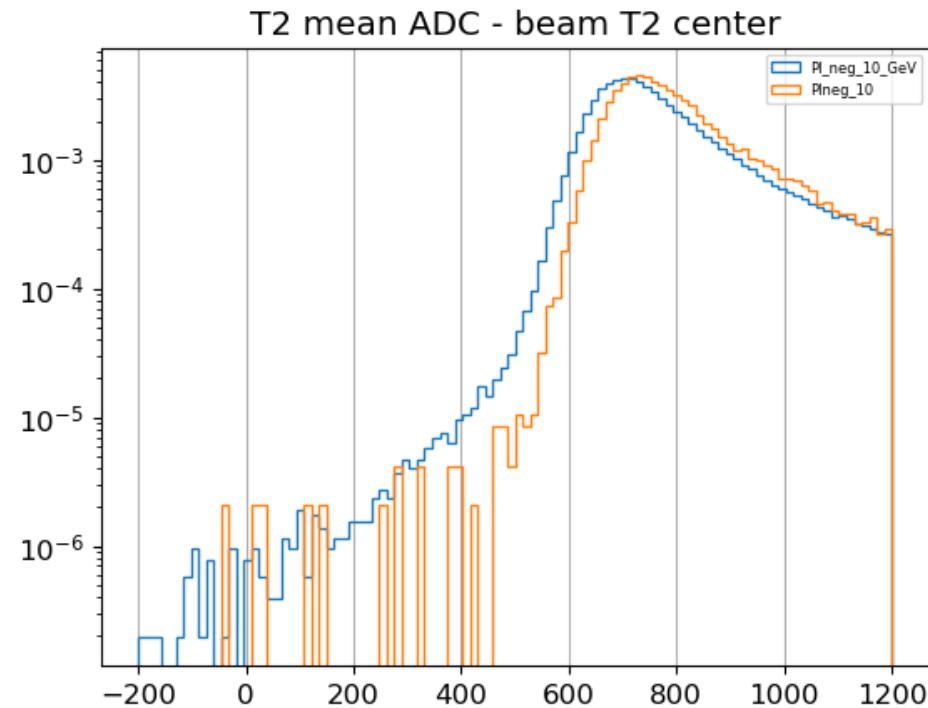


Tile centers – T5



Tile centers – T2

This needs to be checked. Orange distribution is the sum of just 4 low statistics run.



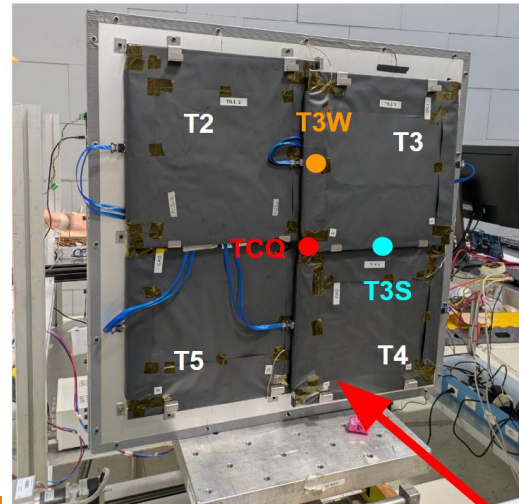
Charge efficiency with Single-ch interface

Single tile efficiency with charge ADC values.
Condition:

- ❑ ADC charge > 5 sigma pedestal
- ❑ 2 channels per PCB AND PCBs

Quadrant efficiency = at least one tile fired

Losing $\sim 2 / 10^4$ evts



	Position	T5	T4	T2	T3	Quad
0	T50	99.973701	4.784657	5.902256	4.067732	99.975469
1	T30	2.842364	3.345122	3.128897	99.989401	99.989754
2	T20	3.357941	3.017303	99.986769	3.082336	99.987890
3	T40	4.591128	99.969231	3.792461	5.674186	99.971869
4	TCQ	99.959153	82.900337	8.996796	89.563248	99.998357
5	T3S	2.721437	44.821669	2.765841	99.993979	99.996237
6	TCQ_2	41.427148	19.160581	37.720877	99.878313	99.986751
7	T3W	2.712012	3.141353	4.501891	99.988463	99.989287

Inefficiency of $\sim 10^{-4}$ coherent with what we got with the ADAPT OR-ed concentrator

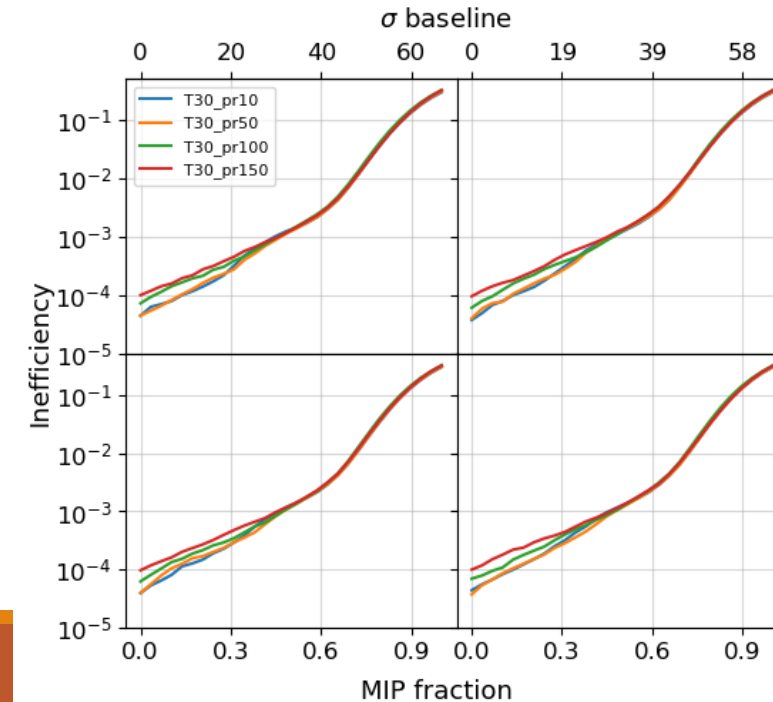
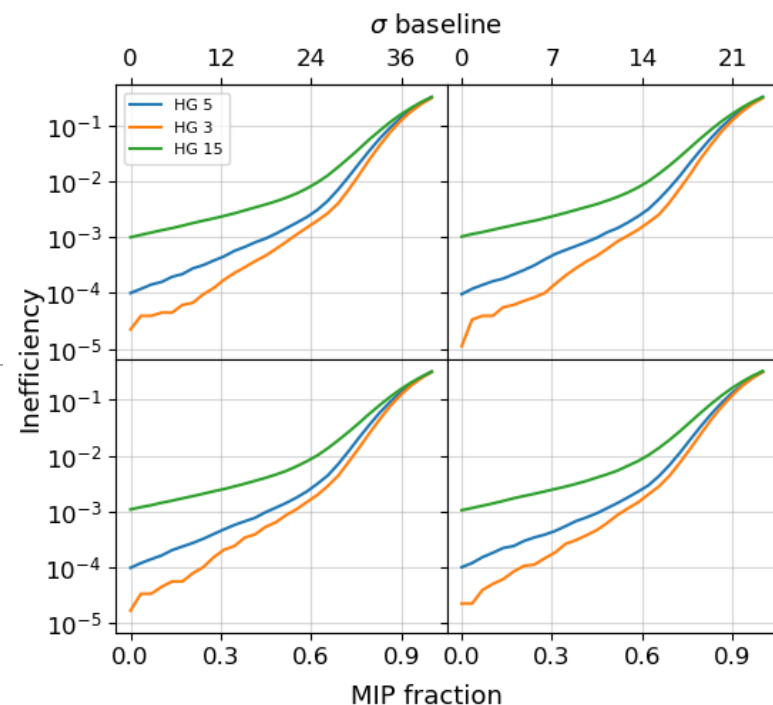
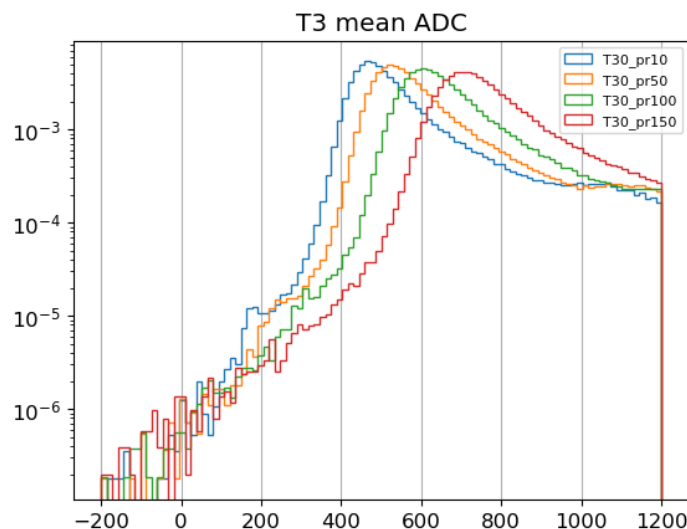
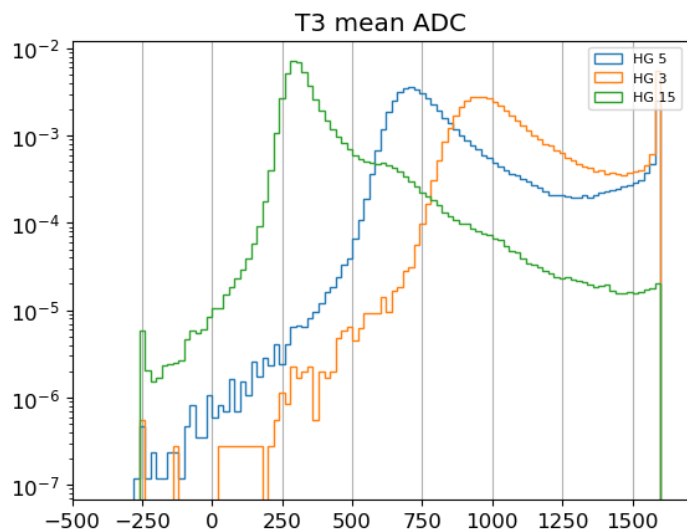
Tile centers – recap

1. Distributions of tile hit by beam shifted to lower charges for -2 GeV, -3 GeV, -1.5 GeV, -4 GeV, -3 GeV , + 1 GeV beams
2. Distributions of other tiles left unchanged. The charge we see in other tiles is due to non synchronous events (scattering, beam profile tails)
3. Even with same beam (same peak), like negative 10 GeV for tile 5, there are differences in the lower energy deposits. Those low-energy charges are probably due to **pile-up effects**.
4. Baseline sigmas were larger for T5 and T4. This are the tiles which probably took more light from the outside. T3 and T2 were well covered with the black blanket

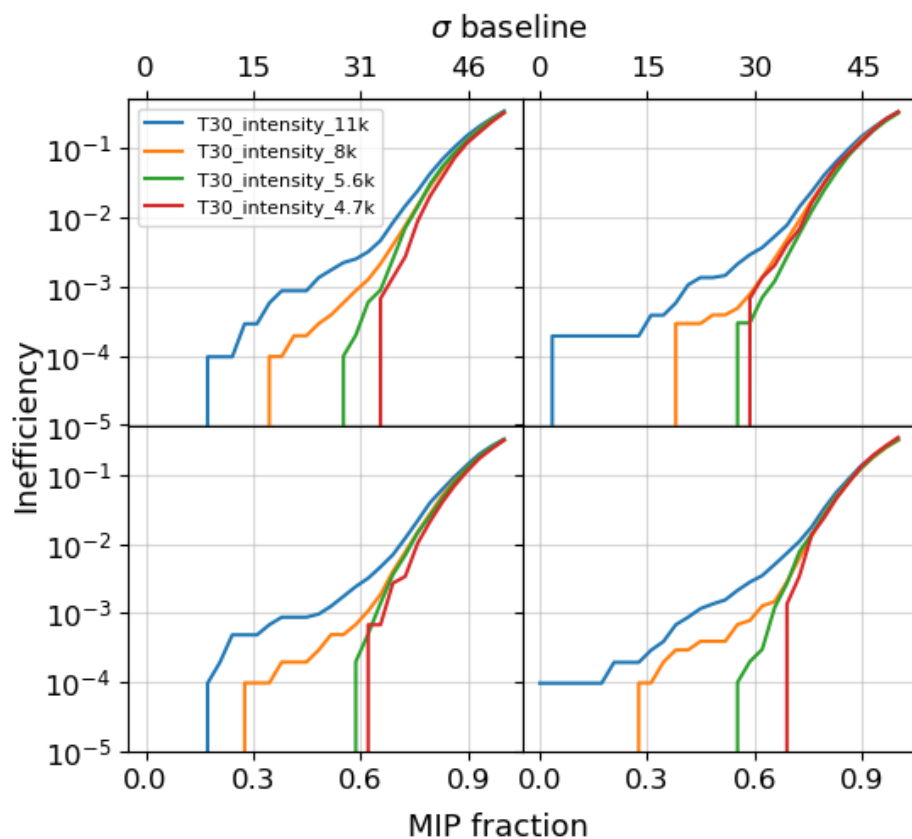
Playing with shaping

Tested response with different parameters:

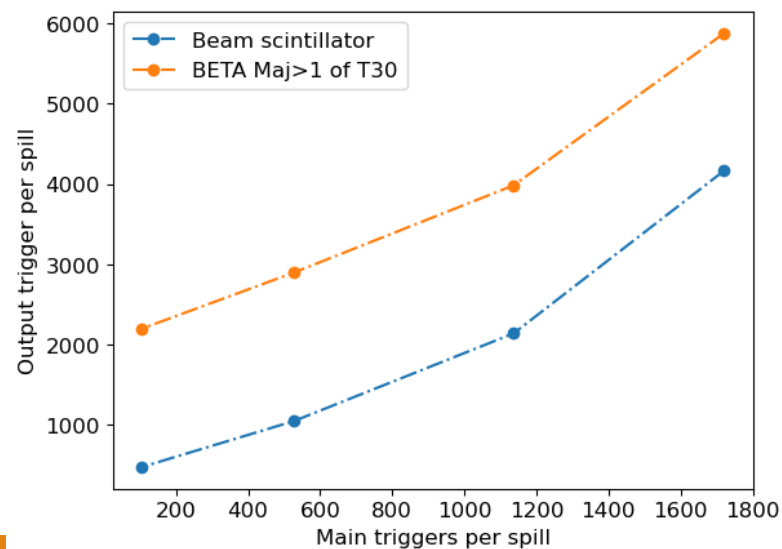
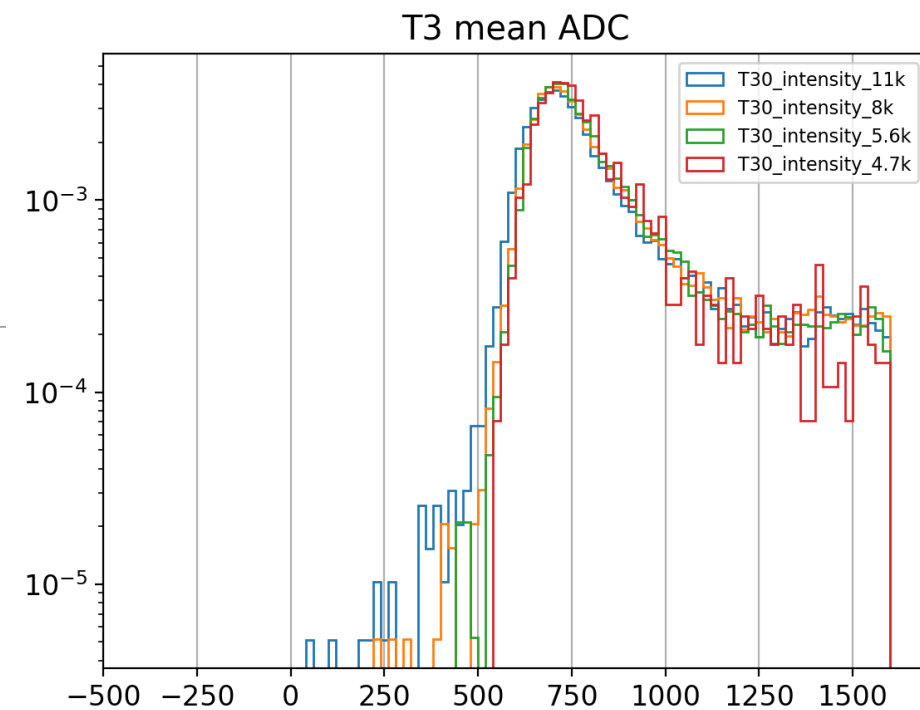
- Gain
- Preamplifier current
- Bias voltage



Playing with beam intensity

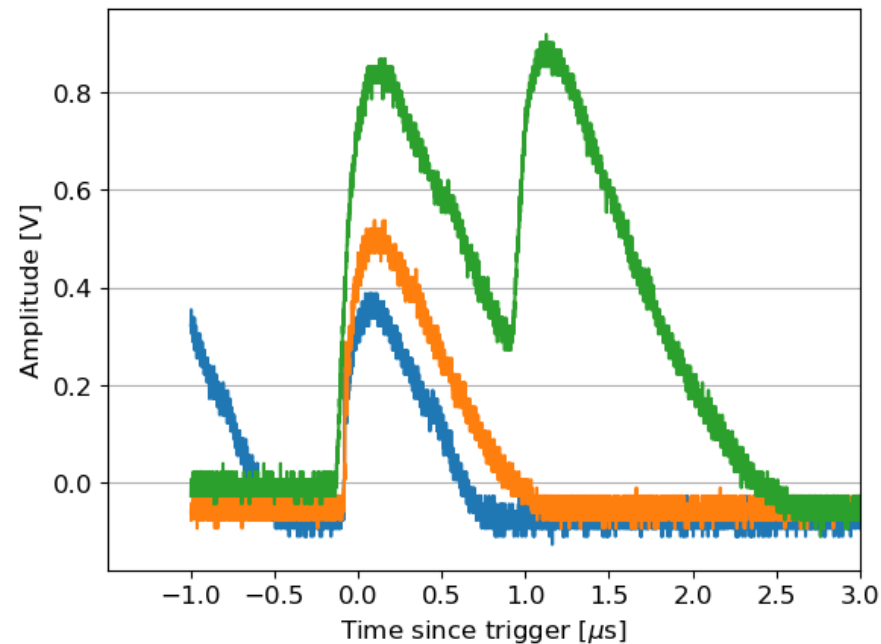


Beam: negative
10 GeV



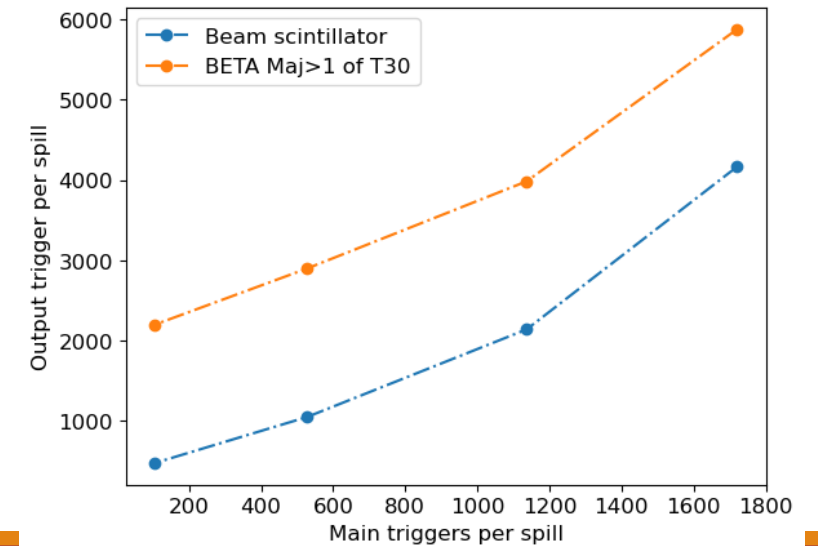
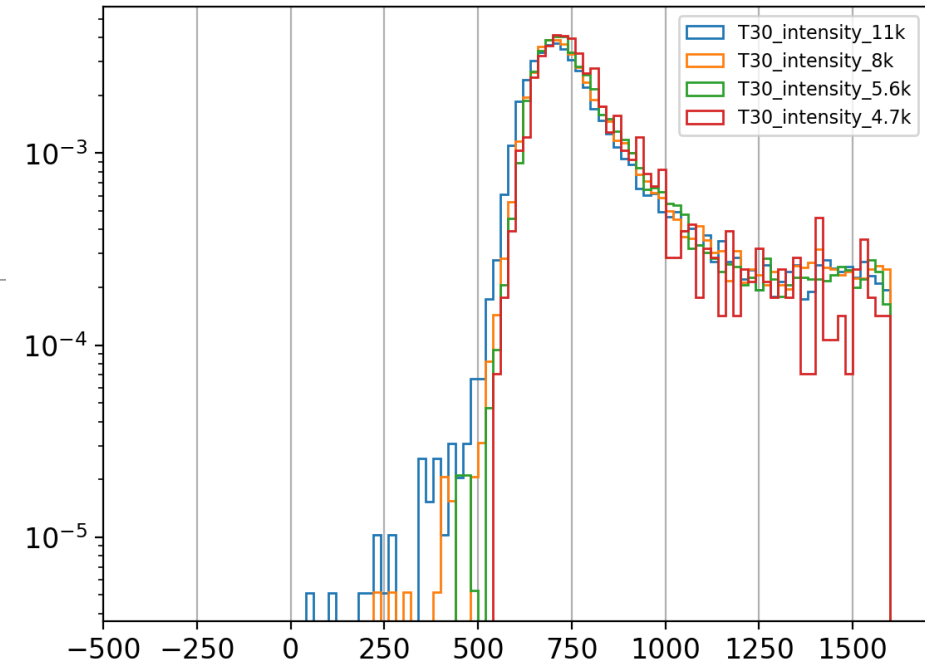
Playing with beam intensity

Acquisition of analog signals of one channel with the oscilloscope



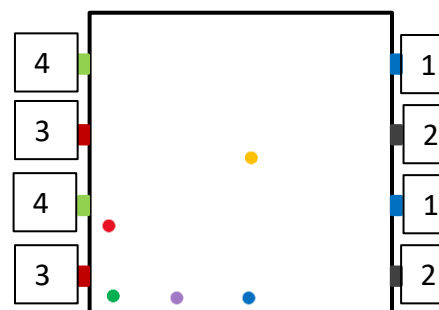
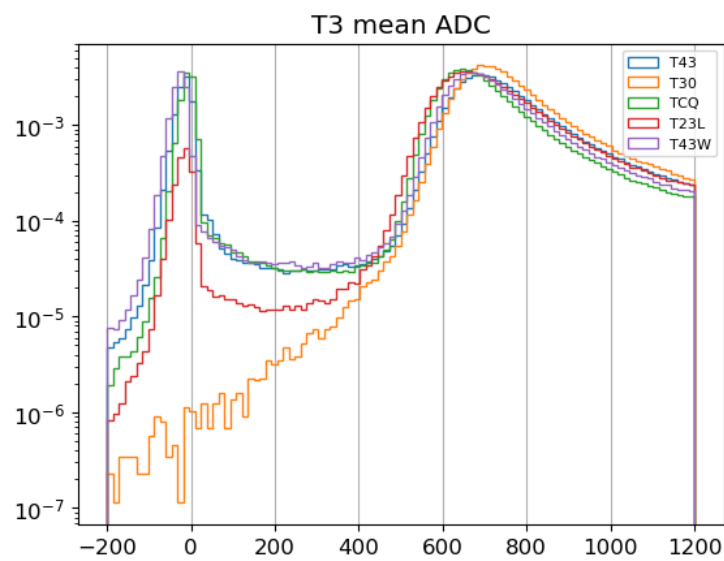
Beam: negative
10 GeV

T3 mean ADC

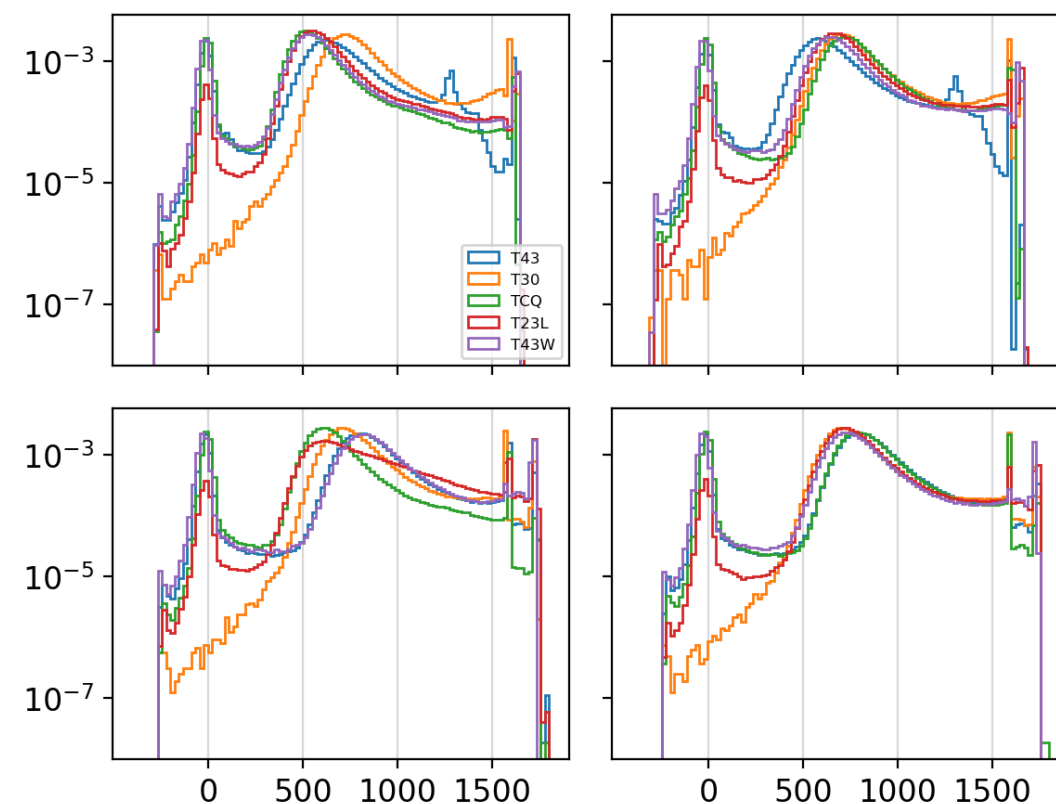


Comparison at different positions – T3

	T43	TCQ	T23L	T43W
Top Left (4)	0.86	0.71	0.75	0.73
Top Right (1)	0.82	1.02	0.94	0.91
Bottom Left (3)	1.12	0.84	0.88	1.15
Bottom Right (2)	1.12	1.11	1.01	1.03

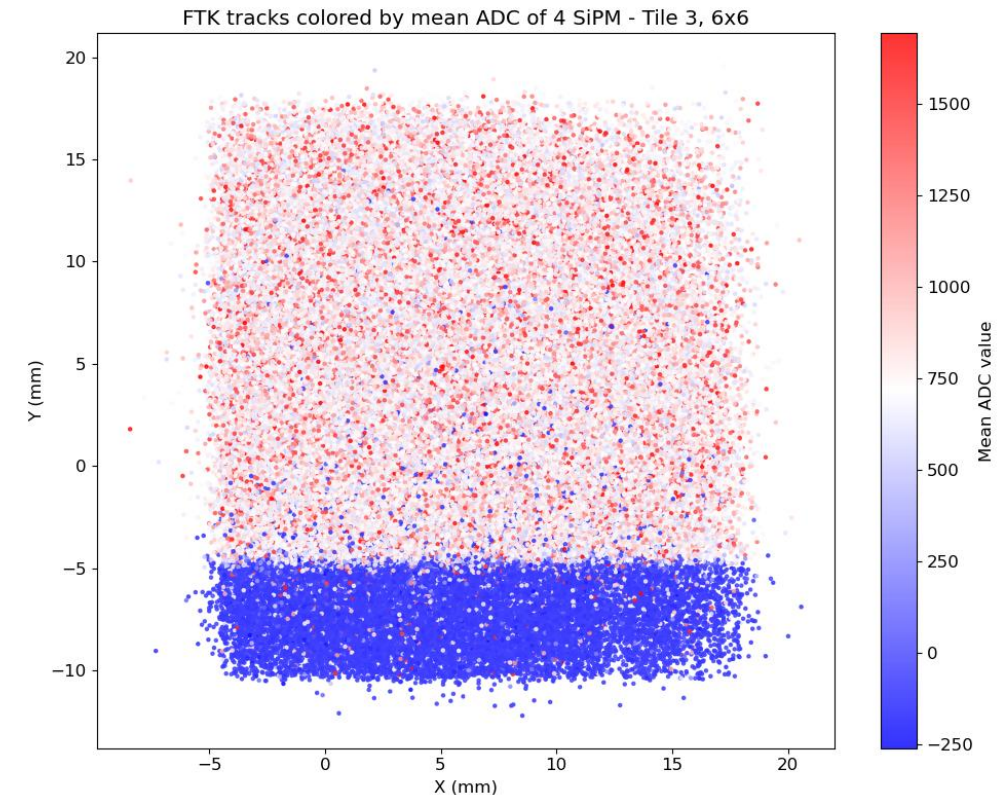
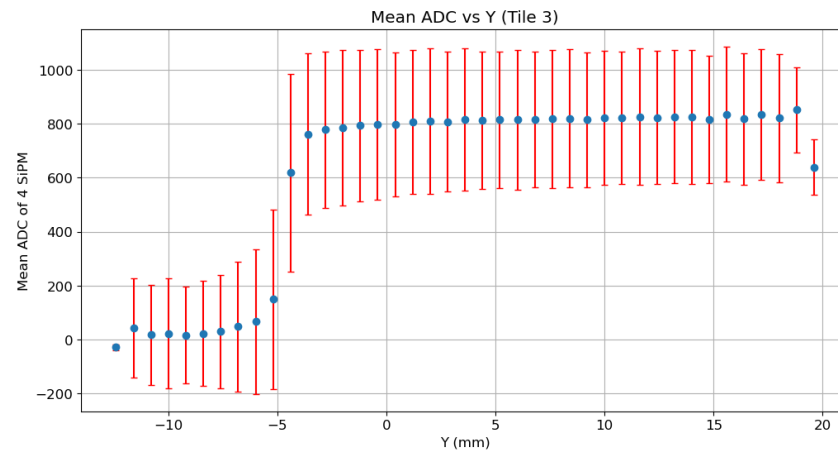
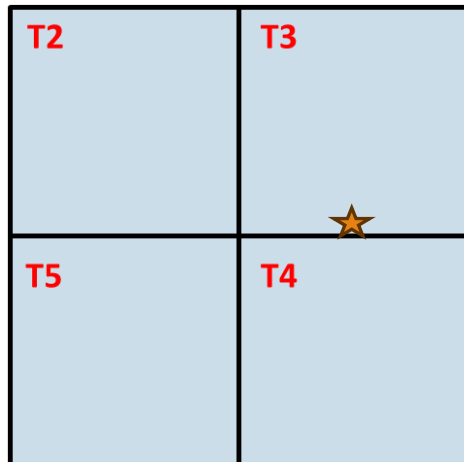


Tile T3



First attempt with SciFi tracker info

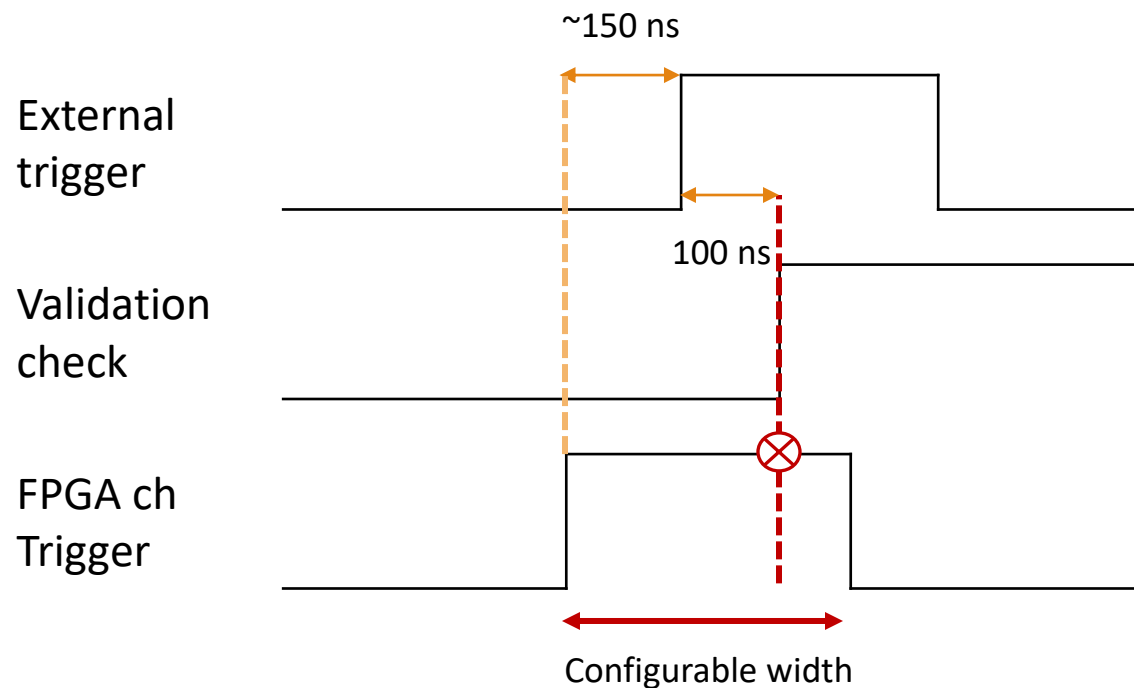
- ❑ Tile uniformity/response can be tested precisely with tracking information
- ❑ This is especially useful when beam was at ACD interfaces
- ❑ 97.5 % efficiency requiring events with $y > -5$ mm



By
G. De Palma
A. Liguori

Triggers and validation

Trigger validation strategy (BETA FEB)



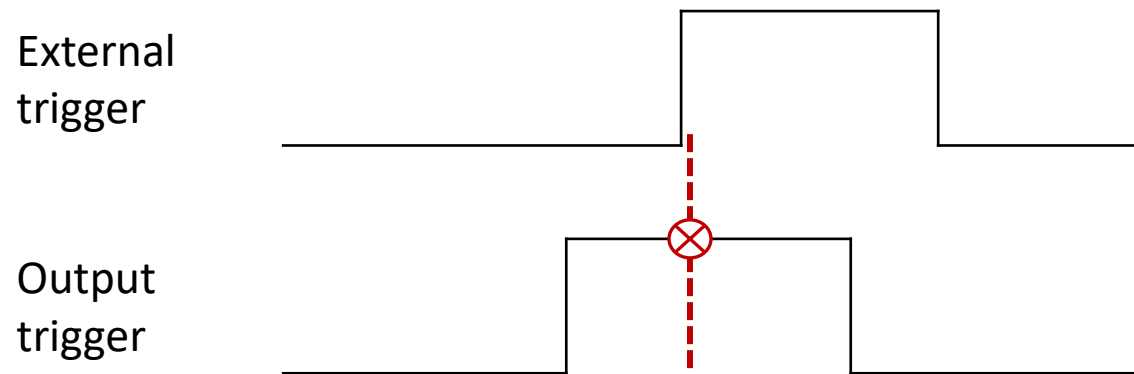
We can check internally the status of the triggers channel by channel

BETA ASIC internal triggers can be either reshaped in fixed-width (tunable) signals, or kept as a copy (TOT) of the original trigger by the FPGA

The external trigger is distributed by a CAEN board which was able to:

- Count incoming triggers from the subdetectors
- Check coincidences and provide the trigger when the condition is met

Trigger validation strategy (CAEN board)



We can check the status of the trigger produced by the BETA FEB FPGA (configurable between majority, map etc) with the CAEN module

BETA ASIC internal triggers can be either reshaped in fixed-width (tunable) signals, or kept as a copy (TOT) of the original trigger by the FPGA

The external trigger is distributed by a CAEN board which was able to:

- Count incoming triggers from the subdetectors
- Check coincidences and provide the trigger when the condition is met

Triggers and validation

Parameters to be optimized:

- ❑ Channels DAC thresholds
- ❑ Majority threshold
- ❑ Coincidence time window, i.e. the width of the triggers of single channels

Aspects which affected the efficiency during the TB:

- Pile ups
- Timing
- Both of these may change with the beam

T5 center - BETA validation

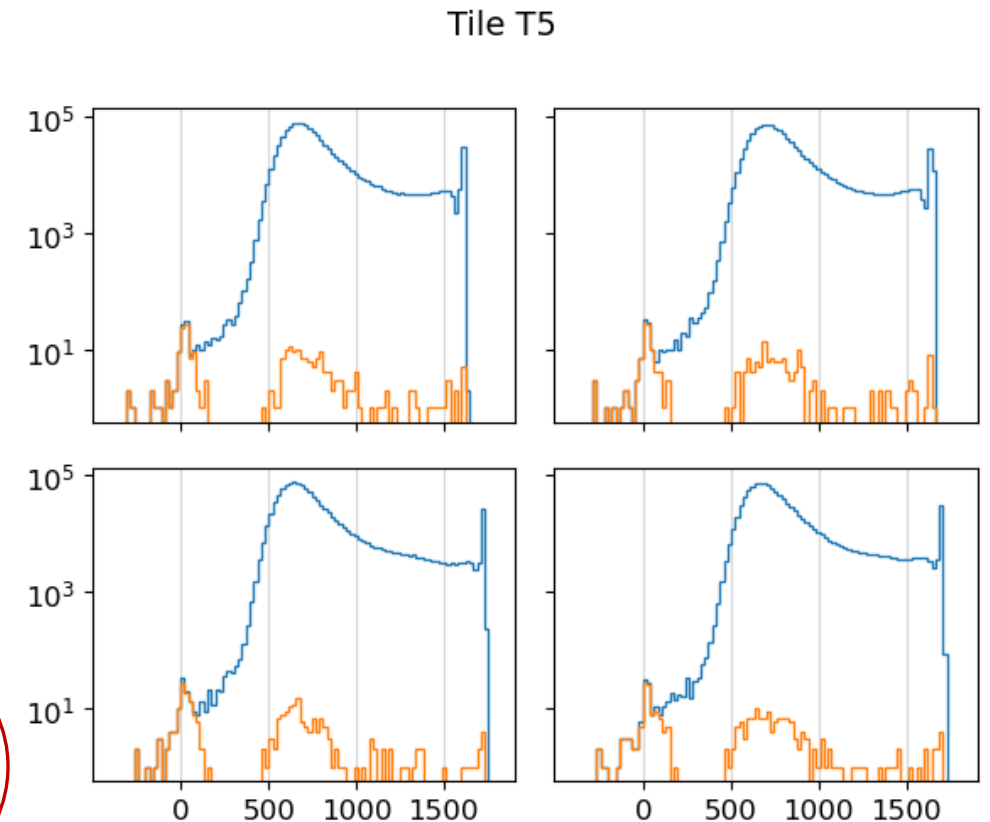
Looking at the internal beta validation of the trigger. Time-Over-Threshold (copy) configuration

Fixed DAC thresholds for all channels.[~0.25 MIP]

- Single channels validation ~ 99.977 %
- Majorities

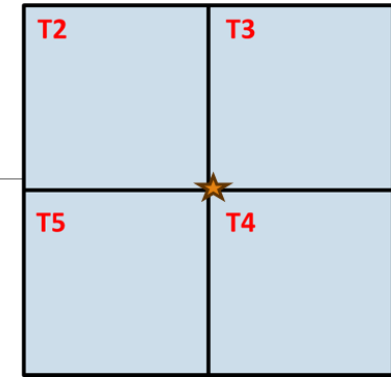


	T2	T3	T4	T5
Maj>1	2.410354	2.001010	2.318659	99.978348
Maj>2	2.343271	1.938184	2.247783	99.976775
Maj>3	2.256110	1.852781	2.154884	99.973815

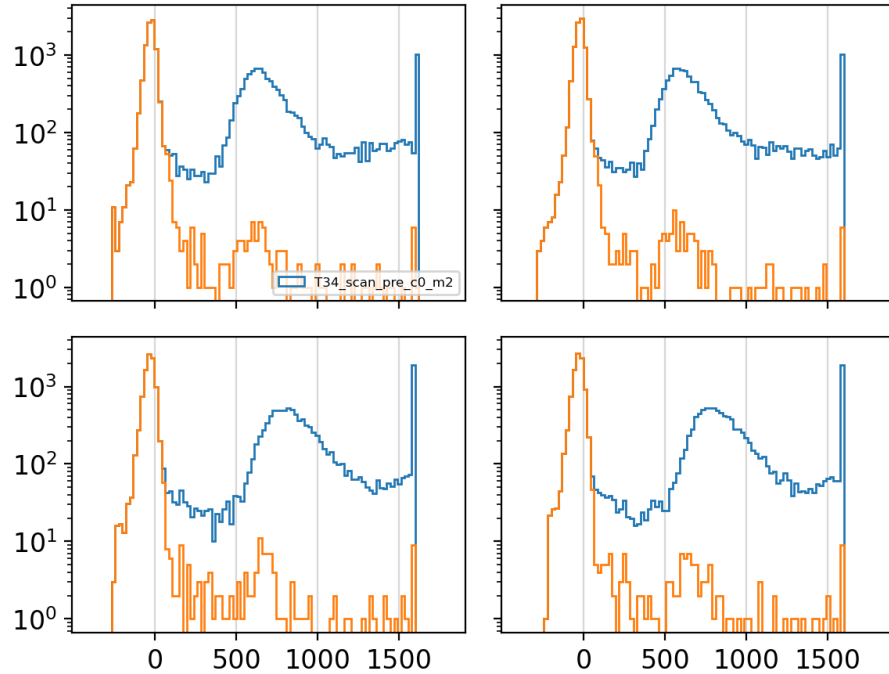


ORANGE NOT validated

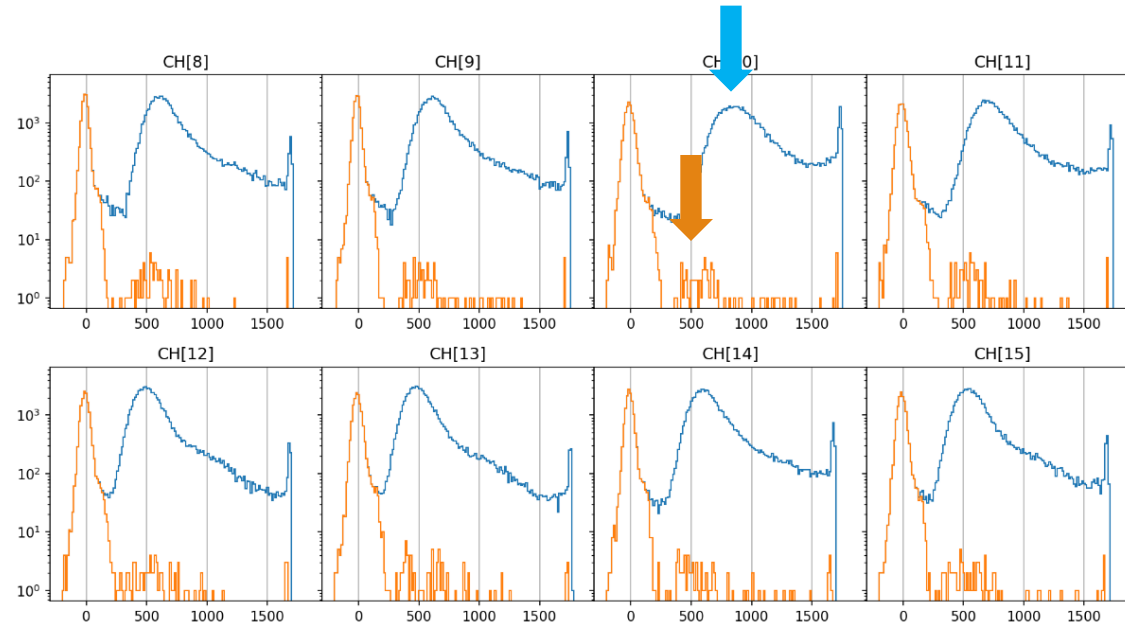
No correlation with beam position



Tile T3 center of quadrant position

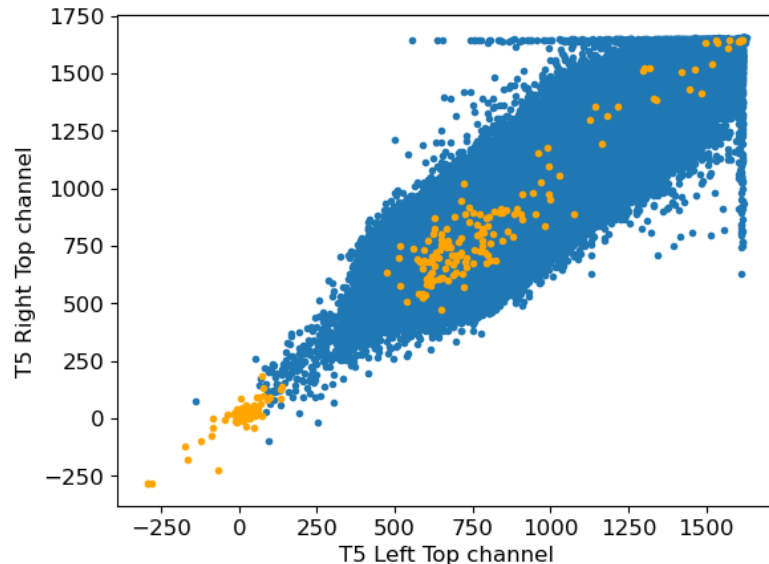


Single SiPM interface – Tile T4 - Center of quadrant position

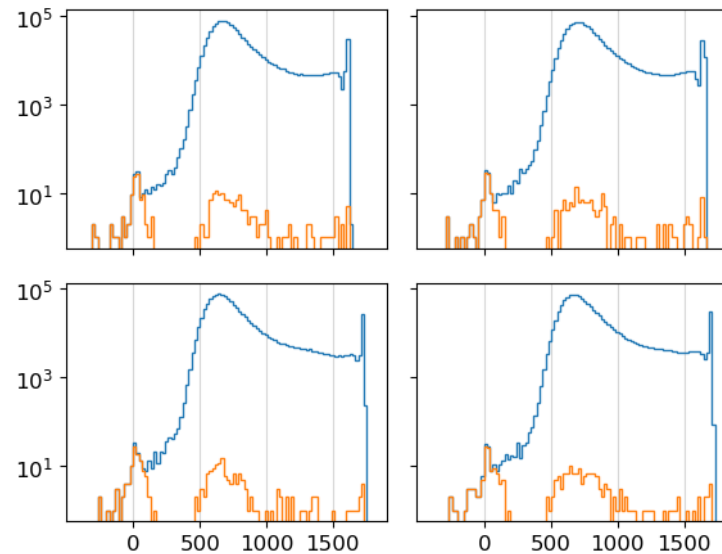


T5 center - BETA validation

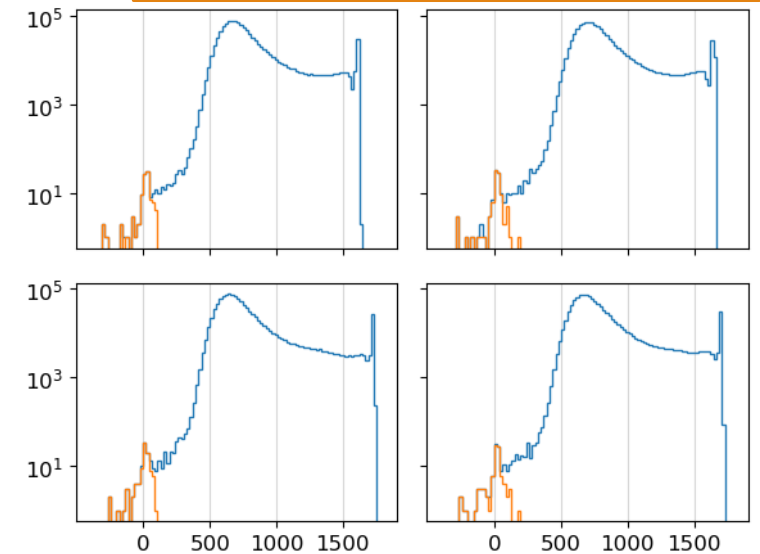
Being T.O.T. the individual triggers should be high above threshold. So why these non validated evts? FW issues? Trigger inefficiency/timing?



Untriggered Validation for Maj>1

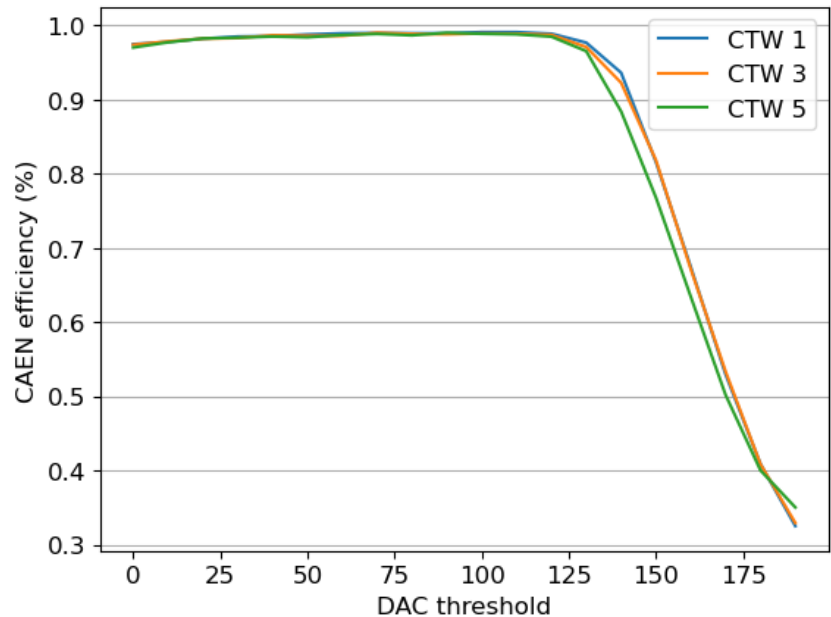


Untriggered ADC for Maj>1



Coincidence time window

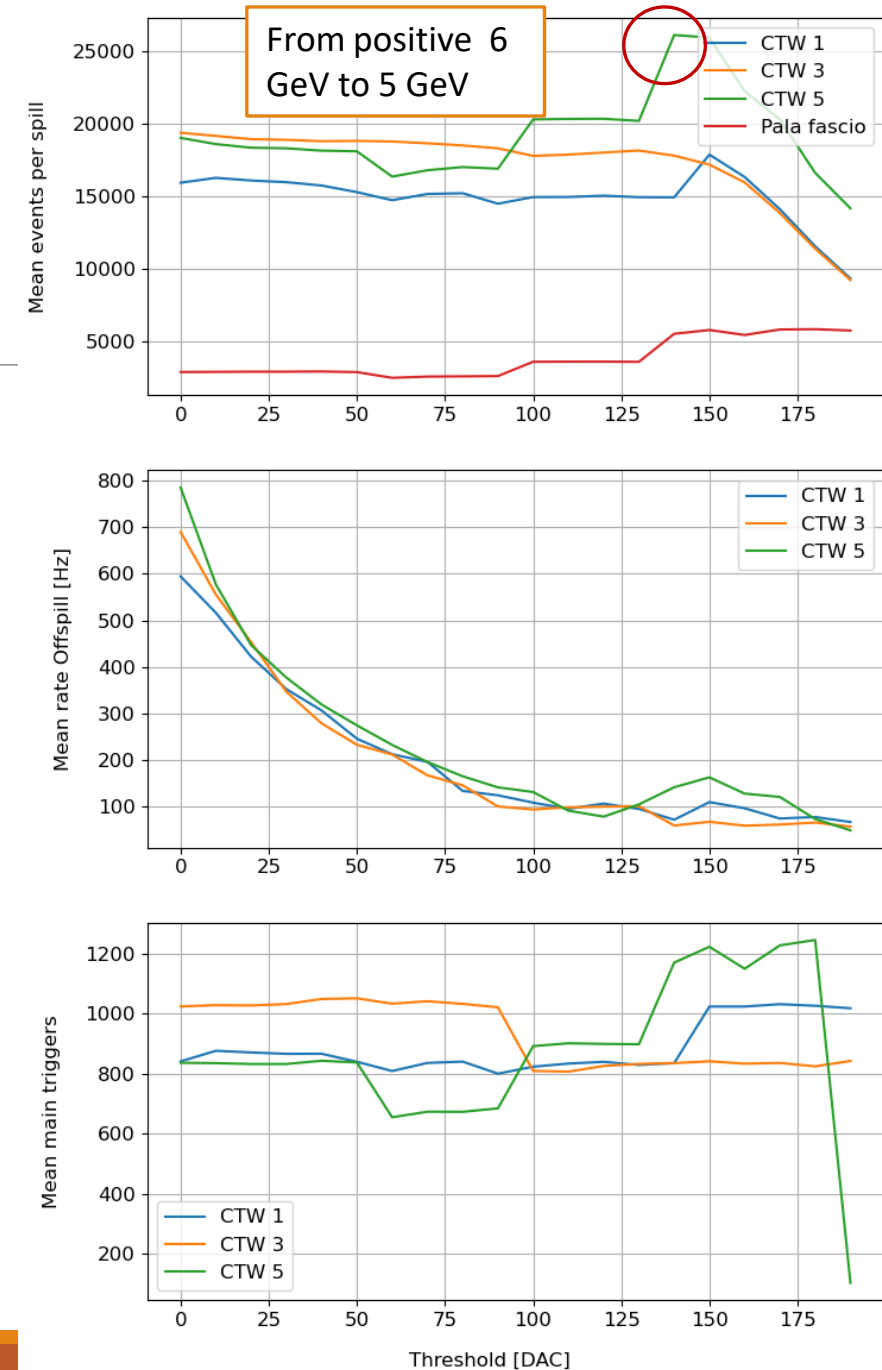
Majority >1 of the T4 tile monitored with the CAEN



In terms of efficiency it seems there is no difference in the CTW (with gate)

CTW 1 = 75 ns
CTW 3 = 175 ns
CTW 5 = 275 ns

Same rate off spill

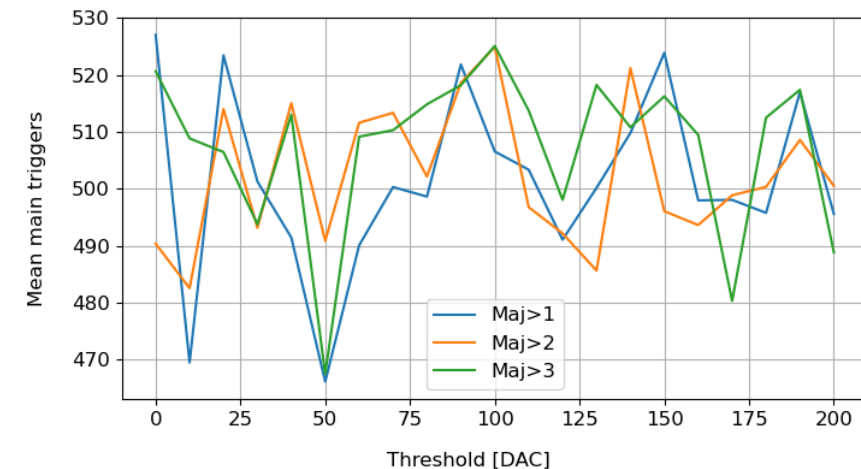
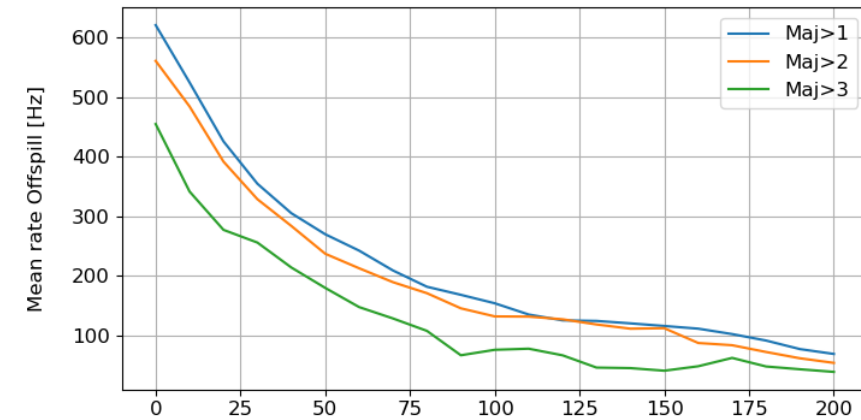
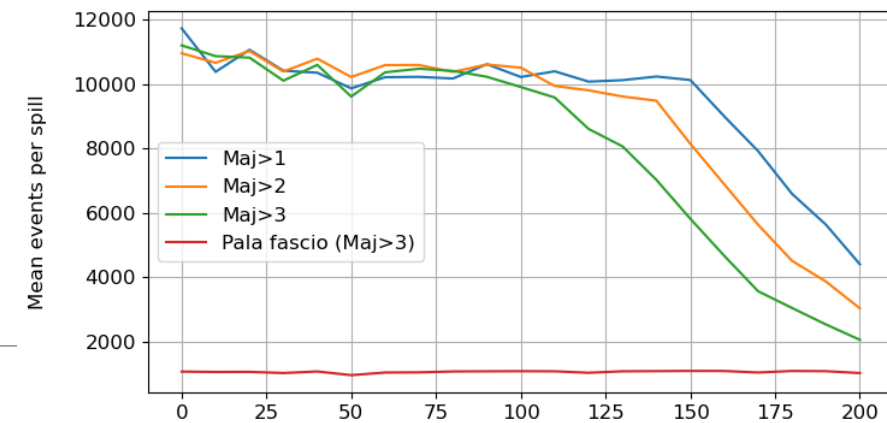
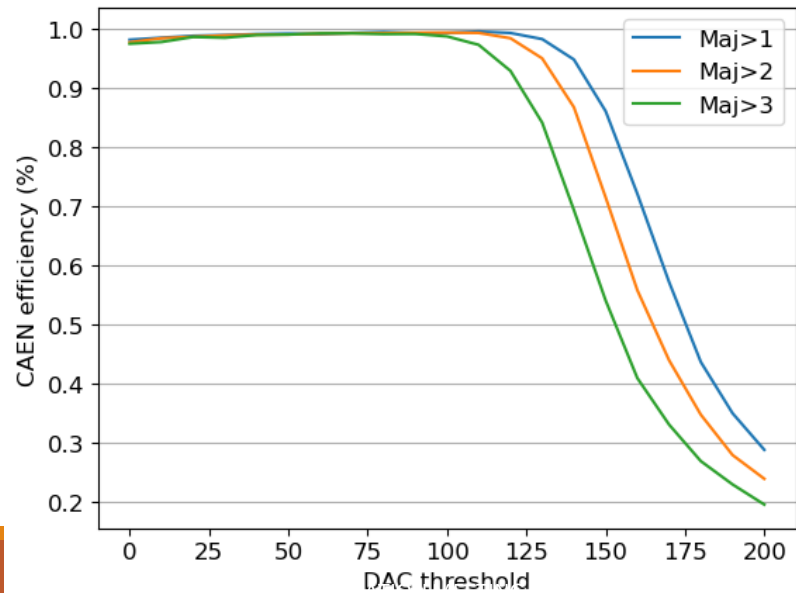
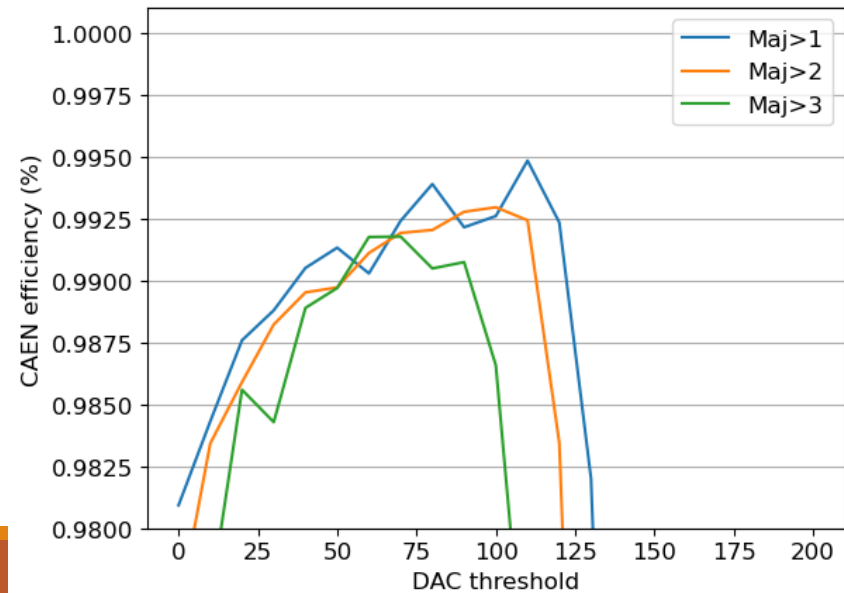


Majority threshold (CTW 1)

CTW1=75 ns , Monitor majority sent to the CAEN

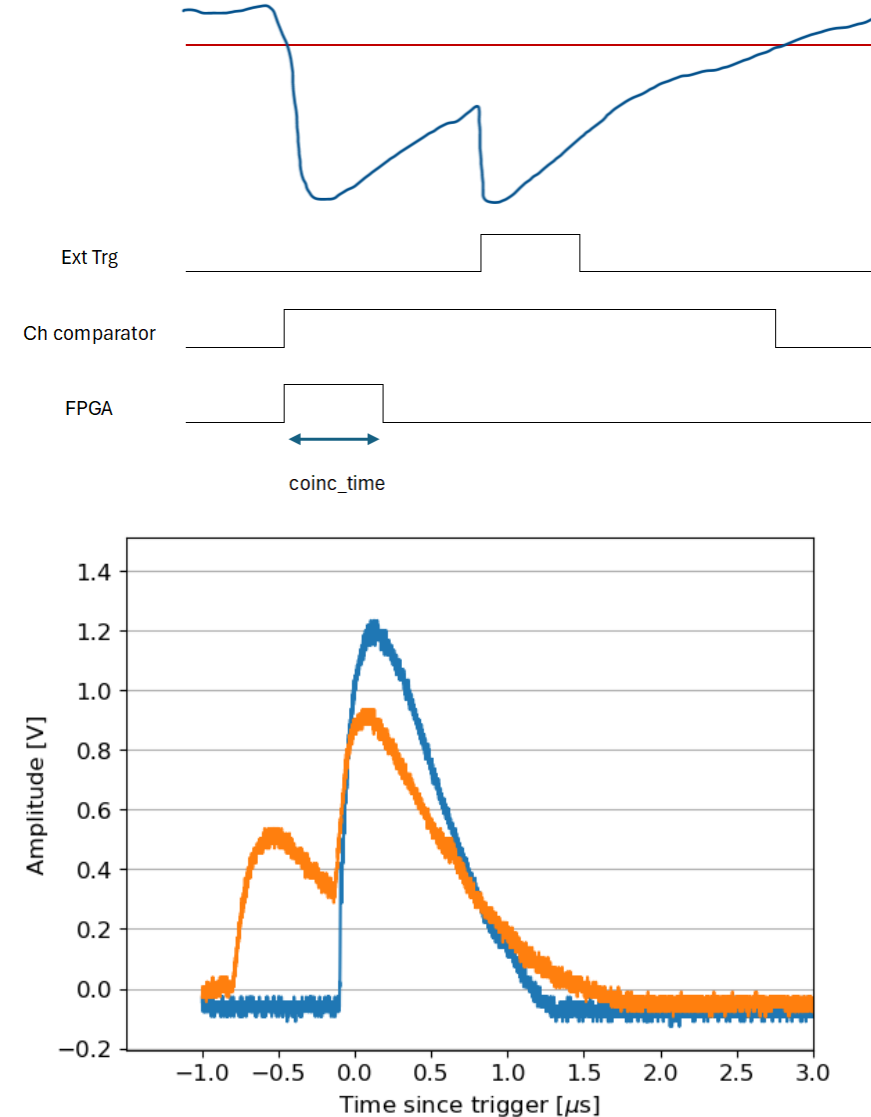
5 GeV positive beam

Below a certain threshold the efficiency and the number of trigger counts are the same



The pile-up

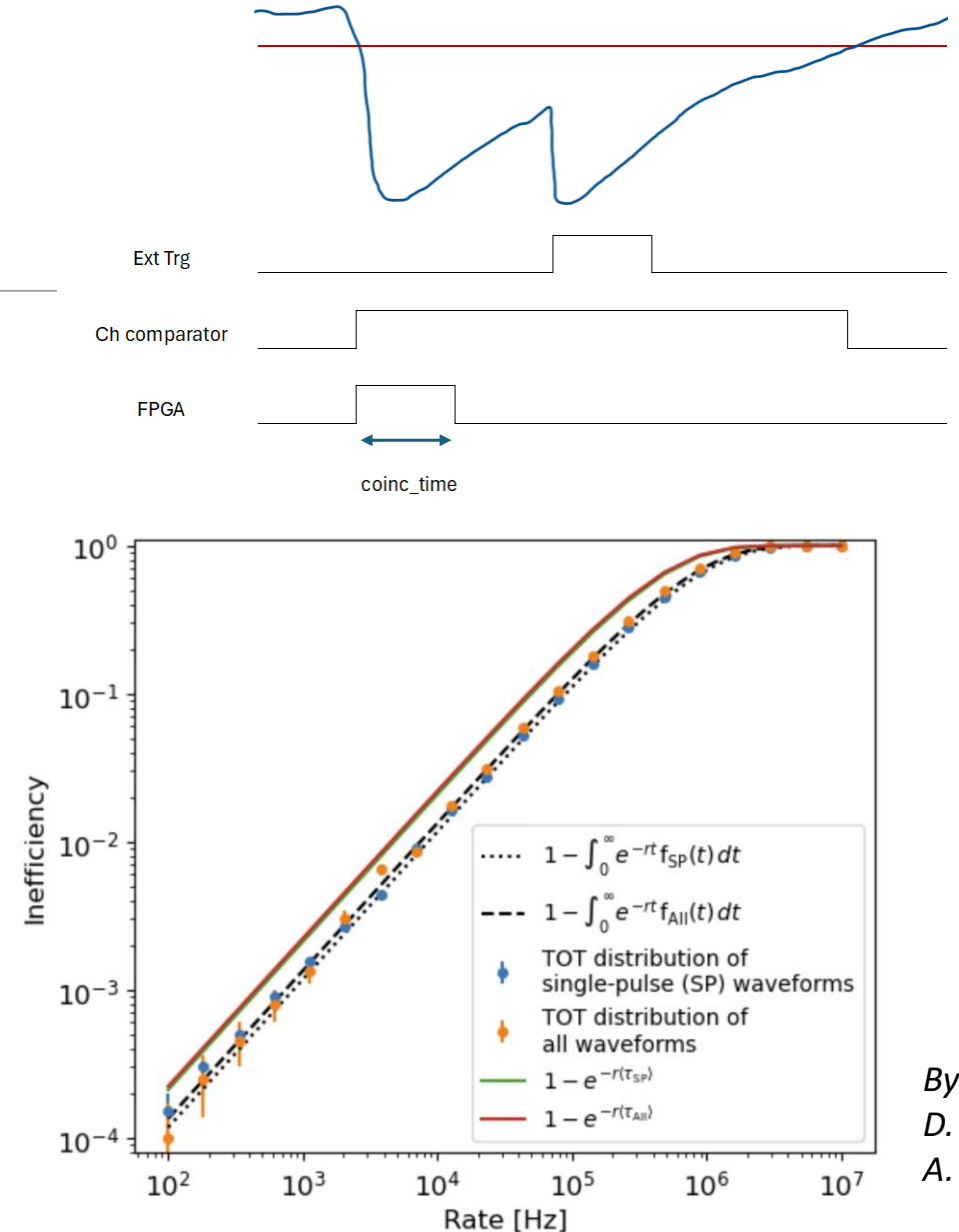
- ❑ Each event induces a dead-time needed for charge/discharge of the preamp analog signal, therefore on the discriminator (trigger signal τ)
- ❑ If another event occurs while the signal is already over-threshold, the two signal sum leading to a longer trigger
- ❑ The information of WHEN the second particle arrived is lost (no leading edge)
- ❑ This poses a limit for the efficiency calculated wrt external system



The pile-up

- ❑ Each event induces a dead-time needed for charge/discharge of the preamp analog signal, therefore on the discriminator (trigger signal τ)
- ❑ If another event occurs while the signal is already over-threshold, the two signal sum leading to a longer trigger
- ❑ The information of WHEN the second particle arrived is lost (no leading edge)
- ❑ This poses a limit for the efficiency calculated wrt external system

At low rates (wrt tau) a good approximation is $\varepsilon \approx 1 - m\tau$



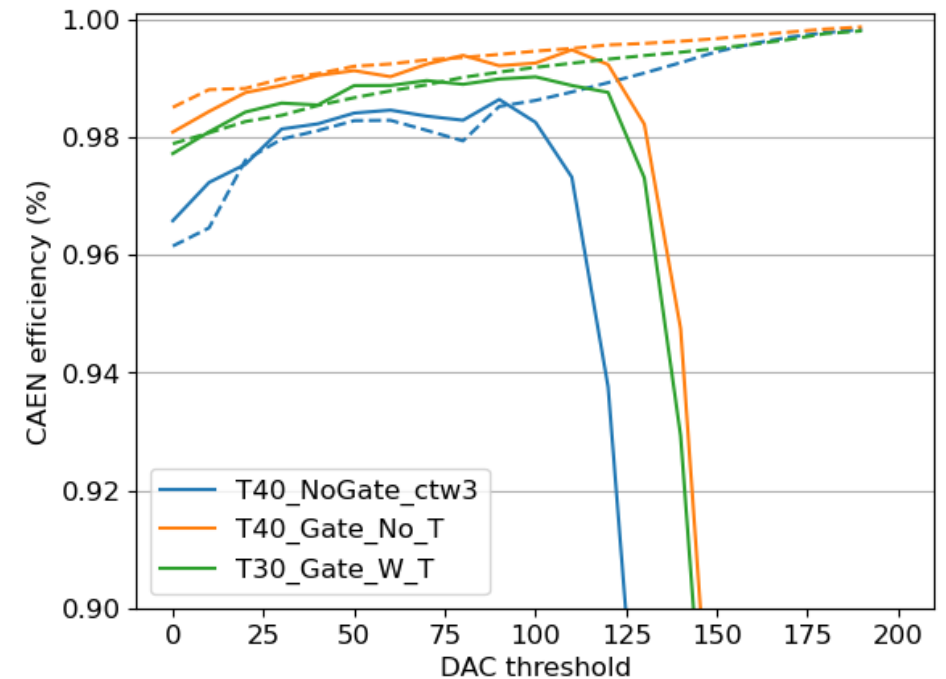
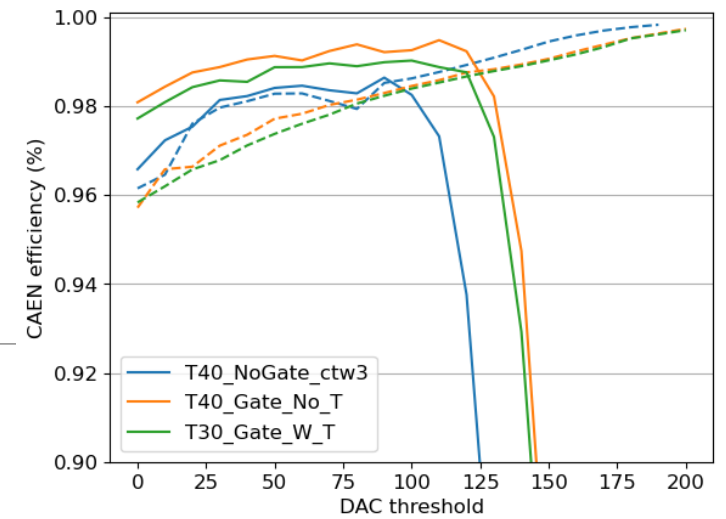
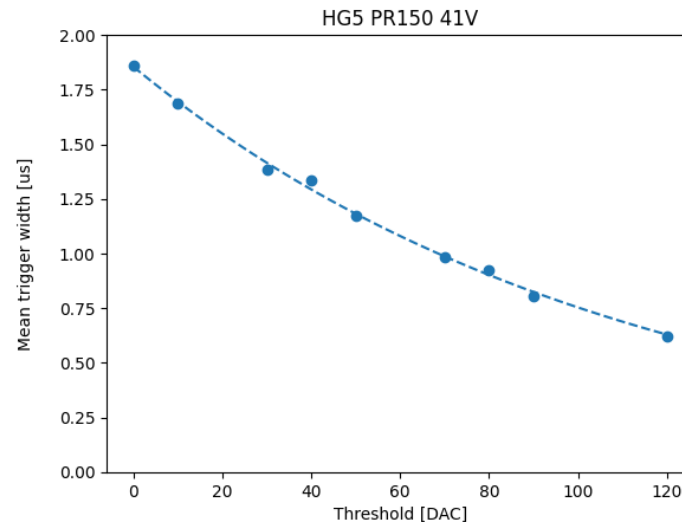
By
D. Cerasole
A. Liguori

Pile-up limit (preliminary)

- Correction with the term $m_{\text{rate detection}} \times \tau$
- It “works” until we had to send the beta trigger to a gate generator. Then i have to apply some corrections on the observed rate
- Need to investigate extensively on all the data (where possible)

From T.O.T. acquisitions with the oscilloscope...

τ changes with the trigger. Lower thresholds means more dead time



Conclusions

- ❑ PS beam test revealed pile-ups effects

- ❑ Absolute efficiency (in charge or trigger) measurements are not feasible with the rate at PS

Nevertheless...

- ❑ We can study tile uniformity response with OR-ed and Single concentrator data

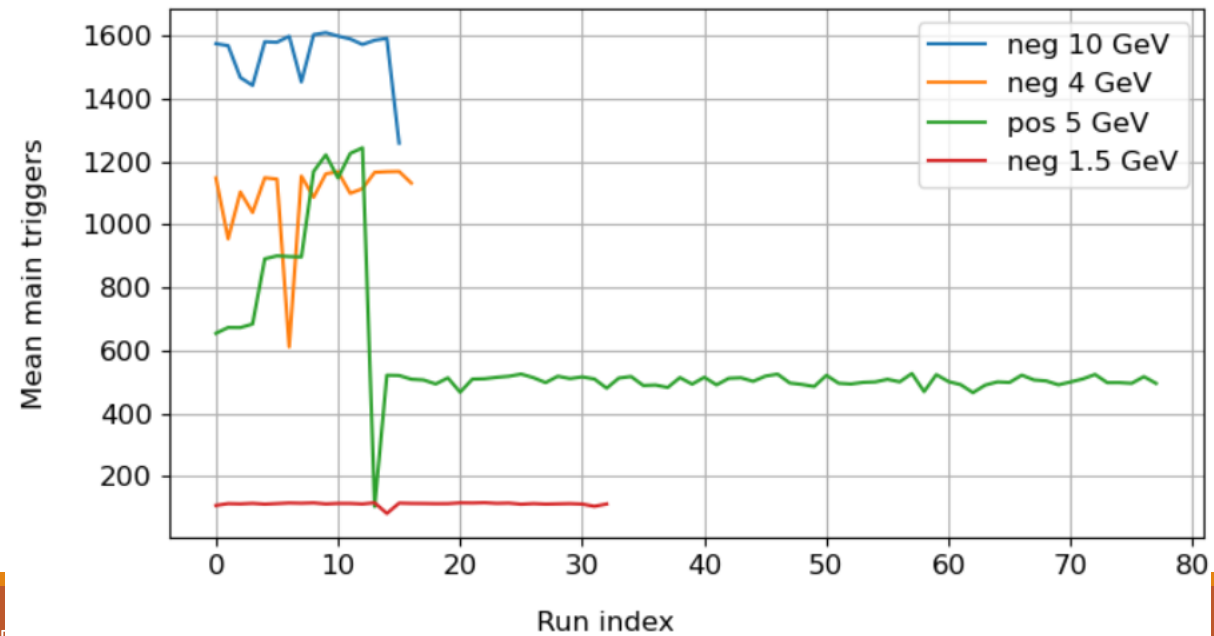
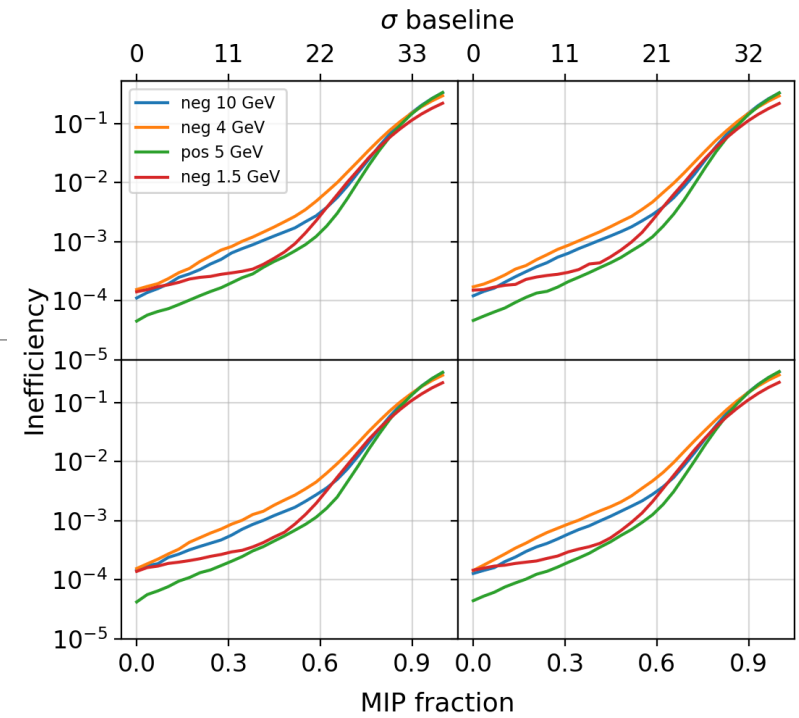
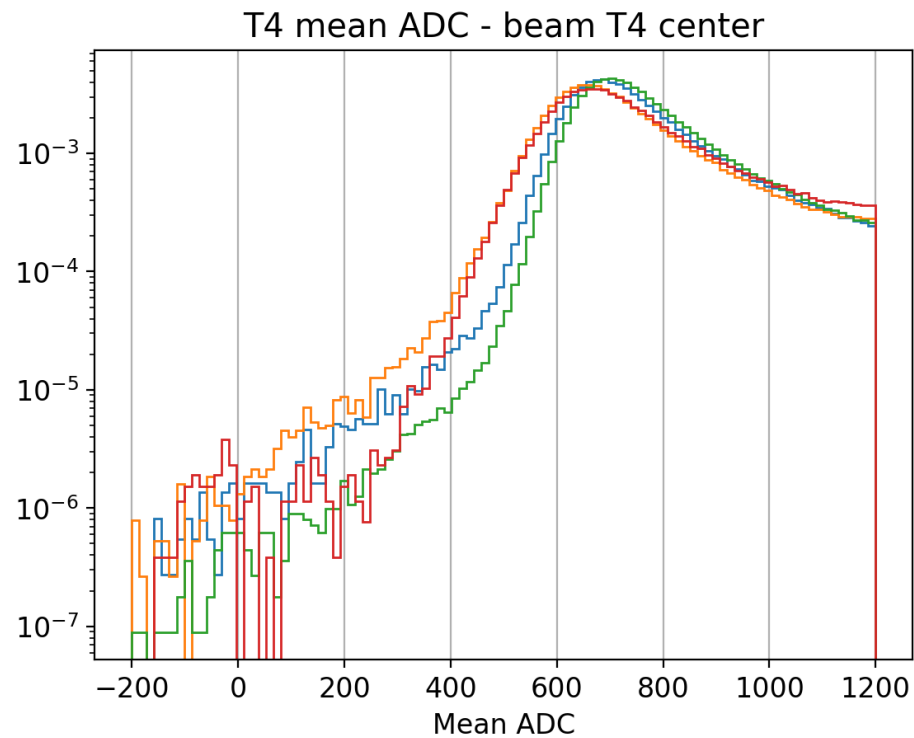
- ❑ We can study pile-up effects, check how much they limit performances with an ADAPT/APT realistic particle environment. And how to compensate (?)

- ❑ Many things need to be verified... there's work to do!

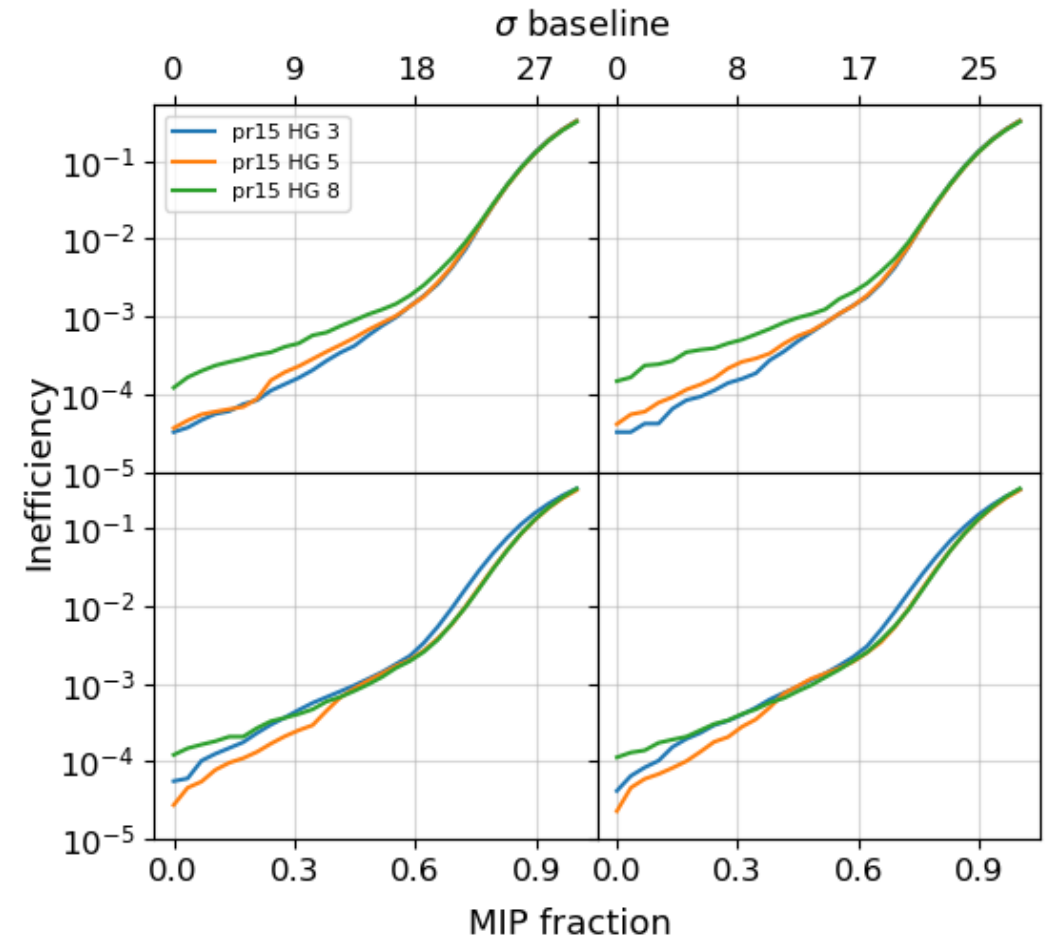
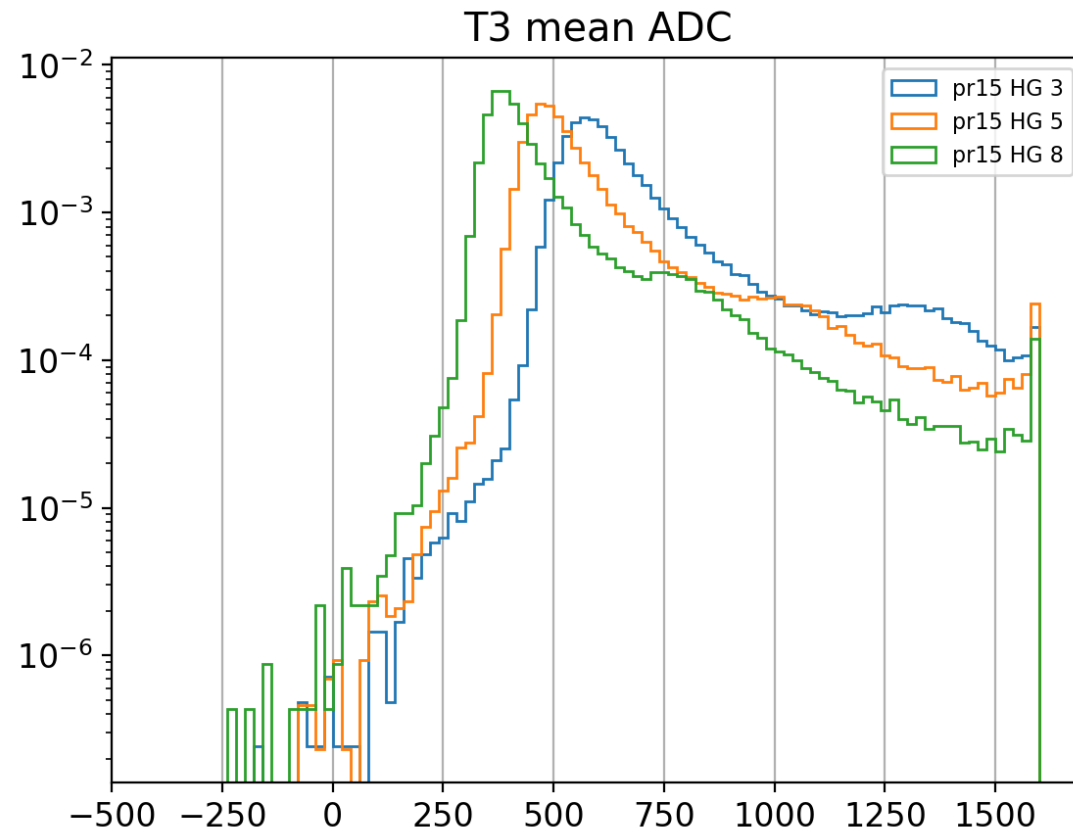
Thanks you for your attention!

Backup

Tile centers –T4



Playing with shaping

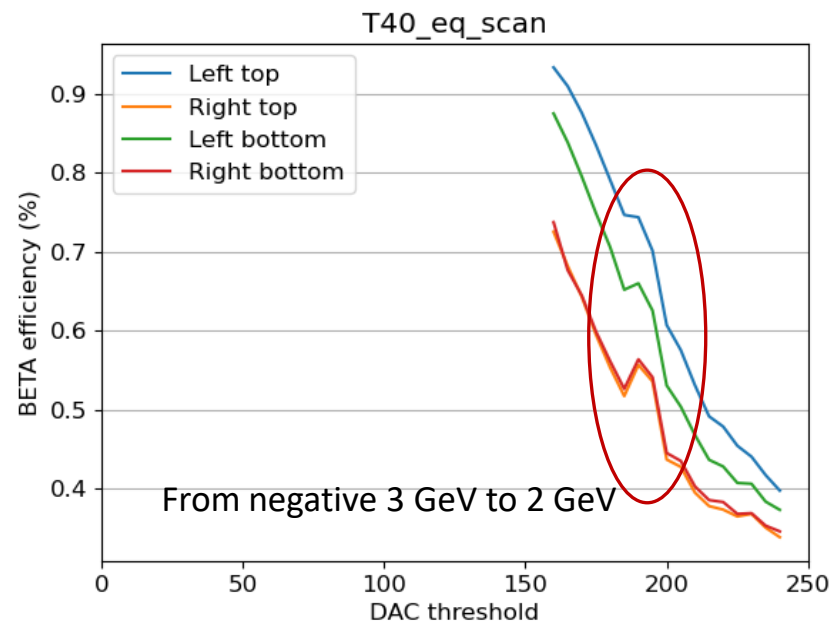
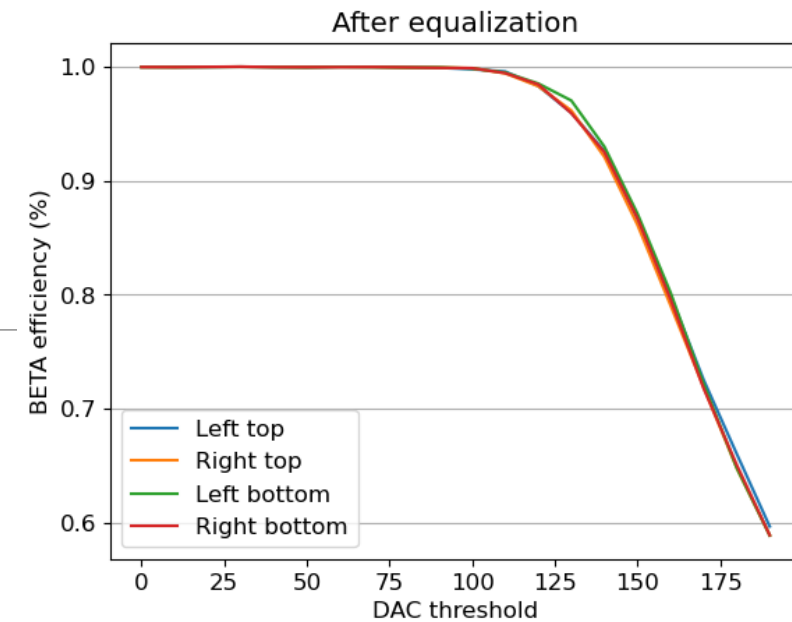


Threshold equalization

Acquisition in external trigger but internal threshold scan.

Checking the validation efficiencies the curves were shifted.

DAC differences evaluated and set for the next scan



Paralyzable model

True rate: n Dead time: τ

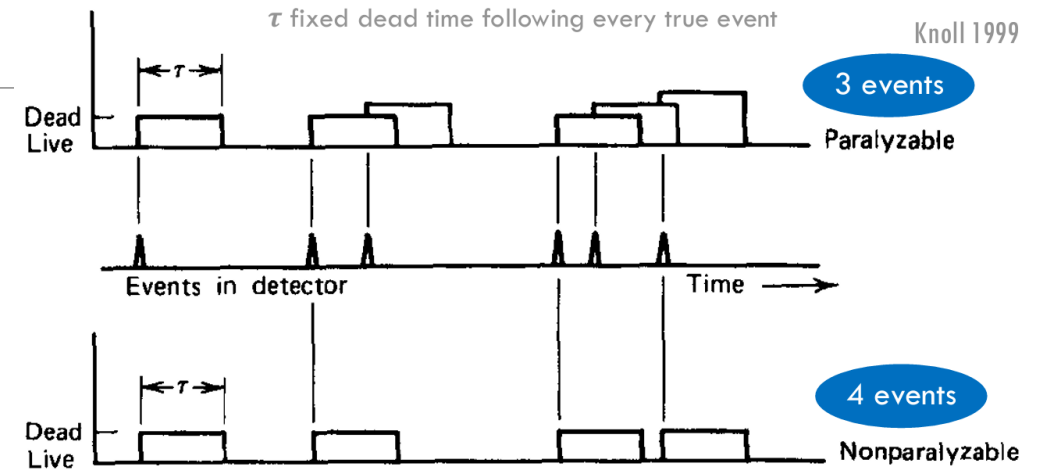
Observed rate: $m = ne^{-n\tau}$

Efficiency: $\varepsilon = \frac{M}{N} = e^{-n\tau}$

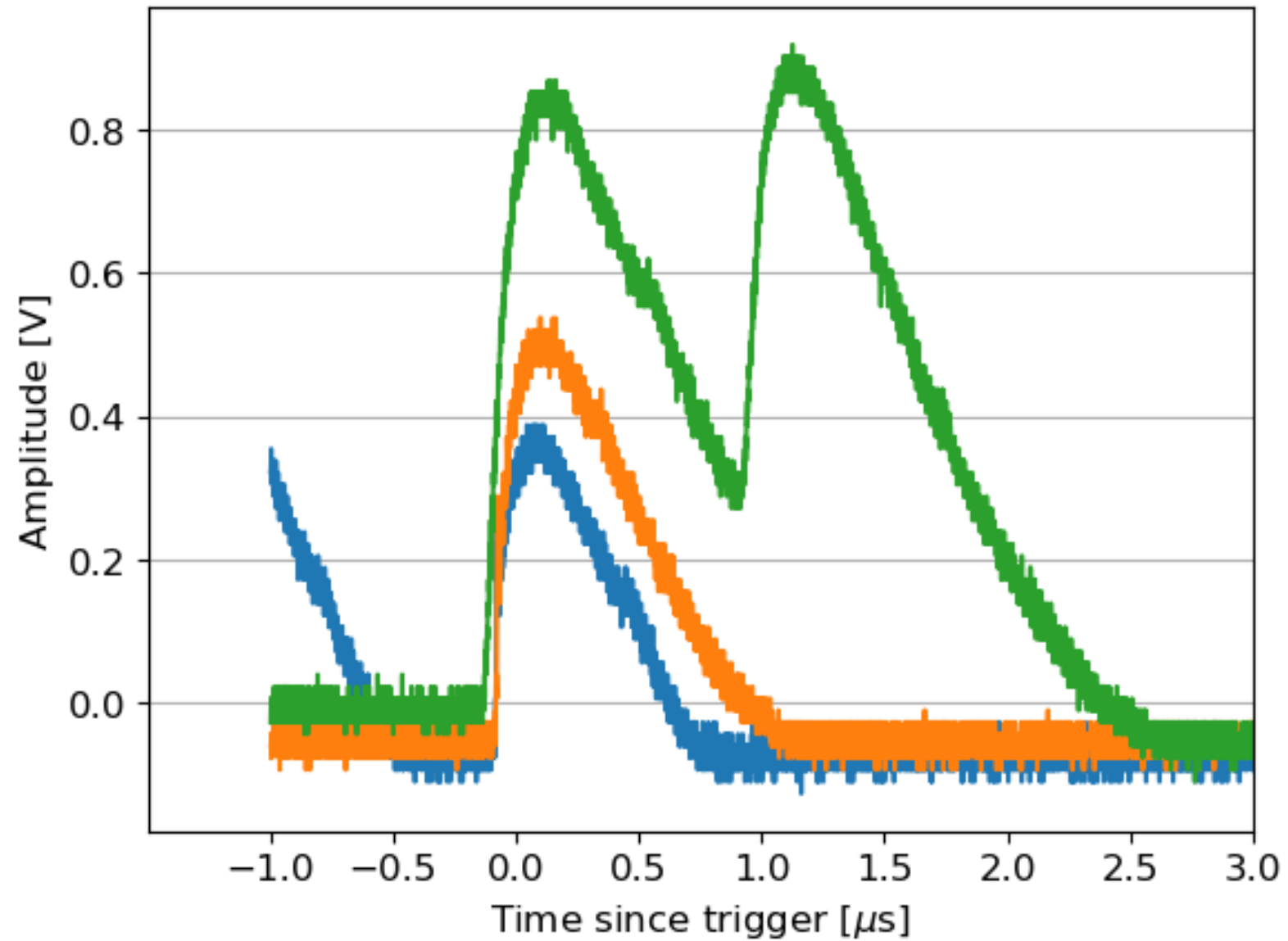
We only know the observed rate m , but at low rates (wrt τ) a good approximation is $\varepsilon \approx 1 - m\tau$

Full correct formula here:

[https://doi.org/10.1016/0168-9002\(91\)90021-H](https://doi.org/10.1016/0168-9002(91)90021-H)



$$\rho = \frac{R}{1 - R\tau - \frac{1}{2}(R\tau)^2 - \frac{2}{3}(R\tau)^3 - \frac{9}{8}(R\tau)^4 - \dots}$$

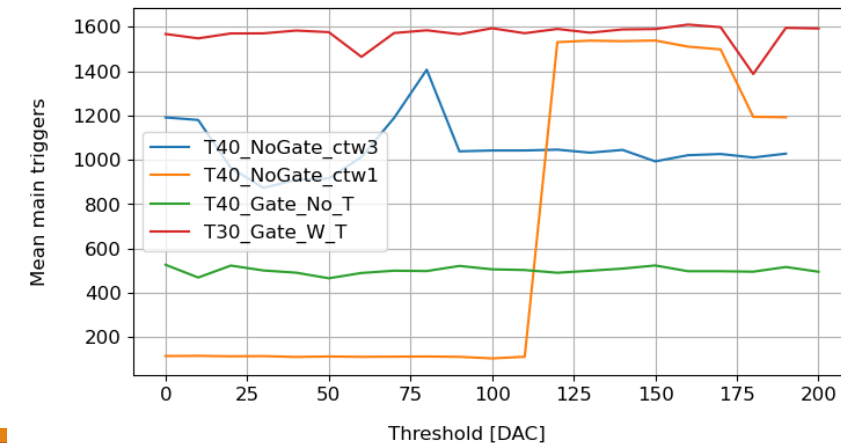
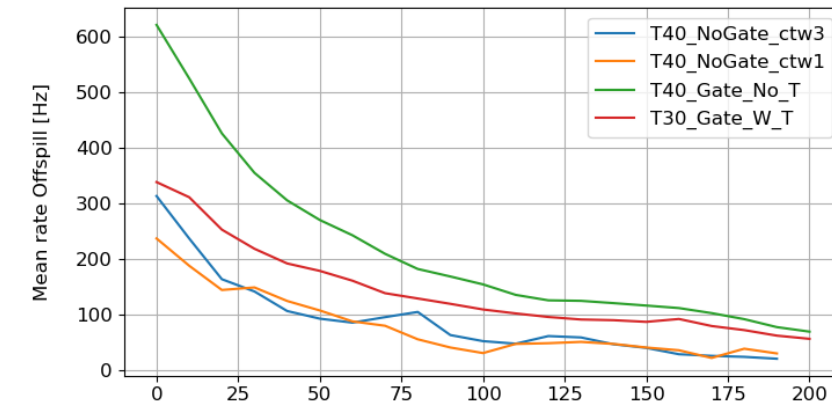
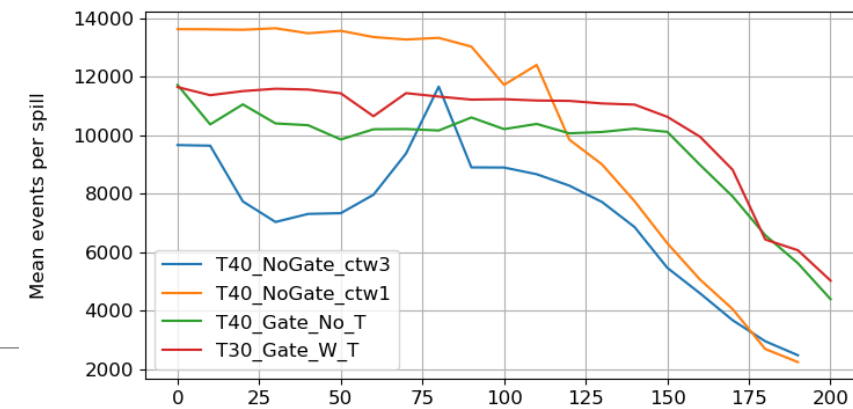
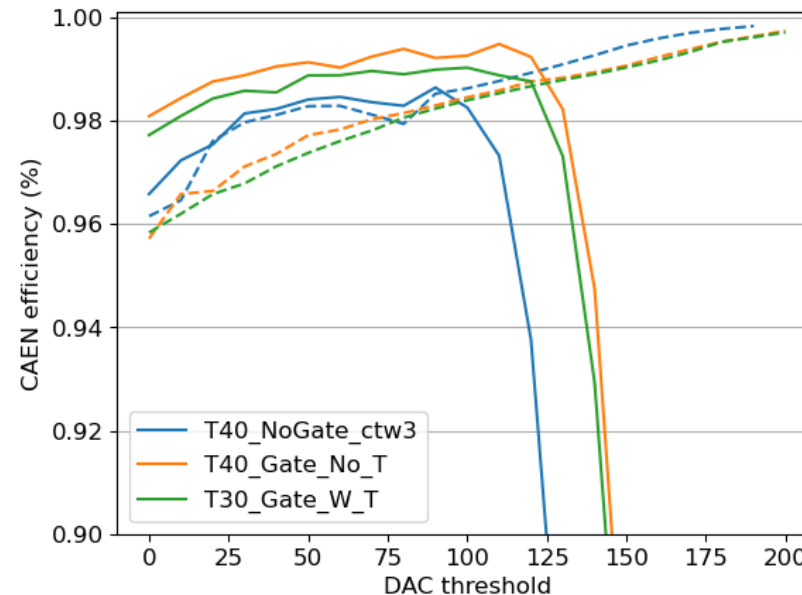


Pile-up probability

Correction with the term, $m_{\text{rate detection}} \times \tau_{MPV}$

It works until we had to send the beta trigger to a gate generator.

Here the comparison with
three central positions taken
in different moments.
Before gate,
After gate (No T),
After terminating gate signal



Pile-up probability

Correction with the term, $m_{\text{rate detection}} \times \tau_{MPV}$

It works until we had to send the beta trigger to a gate generator.

Using the offspill counts to normalize the detection rate to the «no gate» condition, is it possible to recover the efficiency limit

Correzione di un fattore:

~ 0.35 No T

~ 0.5 With T

